







MSP430FR2422

ZHCSHB5D - JANUARY 2018 - REVISED JANUARY 2021

MSP430FR2422 混合信号微控制器

1 特性

- 嵌入式微控制器
 - 16 位 RISC 架构
 - 支持的时钟频率最高可达 16MHz
 - 1.8V 至 3.6V 的宽电源电压范围 (最低电源电压 受限于 SVS 电平,请参阅 SVS 规格)
- 优化的超低功耗模式
 - 工作模式: 120µA/MHz(典型值)
 - 待机:采用 32768Hz 晶振的 LPM3.5 实时时钟 (RTC) 计数器: 710nA(典型值)
 - 关断 (LPM4.5): 36nA, 未使用 SVS
- 低功耗铁电 RAM (FRAM)
 - 非易失性存储器容量高达 7.5KB
 - 内置错误修正码 (ECC)
 - 可配置的写保护
 - 对程序、常量和存储的统一存储
 - 耐写次数达 **10**¹⁵ 次
 - 抗辐射和非磁性
 - FRAM 与 SRAM 之比高达 4:1
- 高性能模拟
 - 高达 8 通道 10 位模数转换器 (ADC)
 - 1.5V 的内部基准电压
 - 采样保持 200ksps
- 智能数字外设
 - 两个 16 位计时器,每个计时器有三个捕捉/比较 寄存器 (Timer A3)
 - 一个仅用作计数器的 16 位 RTC
 - 16 位循环冗余校验 (CRC)
- 增强型串行通信,支持引脚重映射功能(请参阅器 件比较)
 - 一个 eUSCI_A 接口,支持 UART、IrDA 和 SPI

- 一个 eUSCI_B 接口,支持 SPI 和 I²C
- 时钟系统 (CS)
 - 片上 32kHz RC 振荡器 (REFO)
 - 带有锁频环 (FLL) 的片上 16MHz 数控振荡器 (DCO)
 - 室温下的精度为 ±1% (具有片上基准)
 - 片上超低频 10kHz 振荡器 (VLO)
 - 片上高频调制振荡器 (MODOSC)
 - 外部 32kHz 晶振 (LFXT)
 - 可编程 MCLK 预分频器 (1至 128)
 - 通过可编程预分频器 (1、2、4 或 8) 从 MCLK 获得的 SMCLK
- 通用输入/输出和引脚功能
 - 共计 15 个 I/O (采用 VQFN-20 封装)
 - 15 个中断引脚 (P1 和 P2) 可以将 MCU 从低 功耗模式下唤醒
- 开发工具和软件
 - 开发工具
 - 目标开发板 MSP-TS430RHL20
- 系列成员 (另请参阅器件比较)
 - MSP430FR2422: 7.25KB 程序 FRAM、256B 信息 FRAM、2KB RAM
- 封装选项
 - 20 引脚: VQFN (RHL) - 16 引脚: TSSOP (PW)

2 应用

- 工业传感器
- 电池组
- 便携式电器
- 电动牙刷
- 低功耗医疗、健康和健身器材

3说明

MSP430FR2422 是 MSP430™ 超值系列微控制器 (MCU) 产品组合的其中一个器件,该超值系列微控制器是 TI 成 本超低的 MCU 系列,适用于感应和测量应用。MSP430FR2422 MCU 可提供 8KB 非易失性存储器并配备 8 通道 10 位 ADC。该架构、FRAM 和集成外设与多种低功耗模式相结合,针对在便携式和电池供电传感应用中延长电 池寿命进行了优化。采用 16 引脚 TSSOP 或 20 引脚 VQFN 封装。

TI的 MSP430 超低功耗 FRAM 微控制器平台将独特的嵌入式 FRAM 和全面的超低功耗系统架构相结合,从而使 系统设计人员能够在降低能耗的同时提升性能。FRAM 技术兼有 RAM 的低功耗快速写入、灵活性、耐用性和闪 存非易失性等特性。

MSP430FR2422 MCU 由广泛的硬件和软件生态系统进行支持,提供参考设计和代码示例,协助用户快速开展设 计。开发套件包括 MSP-TS430RHL20 20 引脚目标开发板。TI 还提供免费的 MSP430Ware™ 软件,该软件以 Code Composer Studio™ IDE 桌面和云版本组件的形式提供(位于 TI Resource Explorer 中)。E2E™ 支持论坛 还为 MSP430 MCU 提供广泛的在线配套资料、培训和在线支持。

有关完整的模块说明,请参阅《MSP430FR4xx 和 MSP430FR2xx 系列器件用户指南》。



器件信息

| 器件型号(1) | 封装 | 封装尺寸 ⁽²⁾ |
|-------------------|------------|---------------------|
| MSP430FR2422IPW16 | TSSOP (16) | 5mm × 4.4mm |
| MSP430FR2422IRHL | VQFN (20) | 4.5mm × 3.5mm |

- (1) 要获得最新的产品、封装和订购信息,请参阅节 12 中的*封装选项附录*,或者访问德州仪器 (TI) 网站www.ti.com.cn。
- (2) 这里显示的尺寸为近似值。要获得包含误差值的封装尺寸,请参阅机械数据(节12中)。

CAUTION

系统级静电放电 (ESD) 保护必须符合器件级 ESD 规范,以防发生电气过载或对数据或代码存储器造成干扰。如需更多信息,请参阅 《MSP430 系统级 ESD 注意事项》。

4 功能方框图

图 4-1 给出了功能方框图。

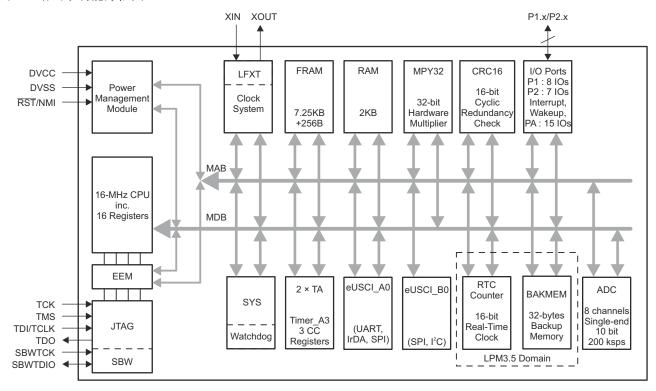


图 4-1. 功能方框图

- MCU 的主电源对 DVCC 和 DVSS 分别为数字模块和模拟模块供电。推荐的旁路电容和去耦电容分别为 $4.7 \,\mu\,F$ 至 $10 \,\mu\,F$ 和 $0.1 \,\mu\,F$,精度为 $\pm 5\%$ 。
- P1 和 P2 特有引脚中断功能,可将 MCU 从所有 LPM 唤醒(包括 LPM3.5 和 LPM4)。
- 每个 Timer_A3 具有 3 个捕捉/比较寄存器,不过仅 CCR1 和 CCR2 从外部连接。CCR0 寄存器仅用于内部周期时序和生成中断。
- 在 LPM3.5 模式下, RTC 模块可在其他外设停止工作的情况下继续工作。



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5 Revision History

注:以前版本的页码可能与当前版本的页码不同

Changes from revision C to revision D

| С | Changes from December 11, 2019 to January 29, 2021 | Page |
|---|--|----------------|
| • | 更新了整个文档中的表格、图和交叉参考的编号格式 | 1 |
| • | | |
| • | Corrected the assignments for TA0.2 and TA0.1 for RHL pins 16 and 17 and PW pins 12 and 13 in 表 7- | |
| | Attributes | |
| _ | No construction of the contribution of the con | |
| | Changes from revision B to revision C Changes from August 20, 2019 to December 10, 2019 | Page |
| _ | | Page |
| | Changed the note that begins "Supply voltage changes faster than 0.2 V/µs can trigger a BOR reset" 8.3, Recommended Operating Conditions | 14 |
| • | Added the note that begins "TI recommends that power to the DVCC pin must not exceed the limits" in 8.3, Recommended Operating Conditions | |
| • | Changed the note that begins "A capacitor tolerance of ±20% or better is required" in 节 8.3, Recommended Operating Conditions | 14 |
| • | | |
| | 节 8.12.3.1, XT1 Crystal Oscillator (Low Frequency) | _ |
| • | Shariged the field that begins residence external supersition at both terminates. In profit 2011 | |
| | Oscillator (Low Frequency) | 21 |
| • | Corrected the test conditions for the R _I parameter in † 8.12.8.1, ADC, Power Supply and Input Range Conditions | 3/1 |
| | Added the note that begins " $t_{Sample} = ln(2^{n+1}) \times \tau$ " in $\ddagger 8.12.8.2$, ADC, 10-Bit Timing Parameters | |
| | Added "1.5-V reference factor" in 表 9-18, <i>Device Descriptors</i> | |
| • | Changed the CRC covered end address to 0x1AF5 in note (1) in 表 9-18, <i>Device Descriptors</i> | |
| С | Changes from revision A to revision B | |
| С | Changes from November 8, 2018 to August 19, 2019 | Page |
| • | 更新了 节 1 <i>特性</i> | 1 |
| • | Changed CapTIvate BSWP demonstration board to CapTIvate phone demonstration board in note (11) 8.7, Low-Power Mode (LPM3, LPM4) Supply Currents (Into V_{CC}) Excluding External Current | 16 |
| • | Changed CapTIvate BSWP demonstration board to CapTIvate phone demonstration board in note (19) 8.7, Low-Power Mode (LPM3, LPM4) Supply Currents (Into V _{CC}) Excluding External Current | |
| • | Updated 节 11.2, Device Nomenclature | 71 |
| С | Changes from initial release to revision A | |
| С | Changes from January 12, 2018 to November 7, 2018 | Page |
| • | 更改了节 1 特性 中的列表项 "1.8V 至 3.6V 的宽电源电压范围…" | 1 |
| • | Updated 节 6.1, Related Products | <mark>7</mark> |
| | | 14 |
| • | Changed the MIN value of the V _{CC} parameter from 2 V to 1.8 V in 节 8.3, <i>Recommended Operating</i> | |
| | Conditions | |
| • | Changed the crystal in the footnote that begins "Characterized with a Seiko Crystal SC-32S crystal" in 8.7, Low-Power Mode (LPM3, LPM4) Supply Currents (Into V _{CC}) Excluding External Current | |

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| • | Changed the crystal in the footnote that begins "Characterized with a Seiko Crystal SC-32S crystal" in 7 | Ĩ. |
|---|--|------|
| | 8.8, Low-Power Mode (LPMx.5) Supply Currents (Into V _{CC}) Excluding External Current | . 17 |
| • | Added note on V _{SVSH} - and V _{SVSH+} parameters to † 8.12.1.1, <i>PMM</i> , SVS and BOR | . 19 |
| • | Changed the minimum V_{CC} from 2.0 V to 1.8 V in the test conditions for the f_{REFO} , df_{REFO} / d_{VCC} , and f_{DC} parameters and in note (2) in \ddagger 8.12.3.4, <i>REFO</i> | . 22 |
| • | Changed the minimum V _{CC} from 2.0 V to 1.8 V in the test conditions for the df _{VLO} /dV _{CC} parameter and in | |
| | note (2) in 节 8.12.3.5, Internal Very-Low-Power Low-Frequency Oscillator (VLO) | . 24 |
| • | Changed the minimum V _{CC} from 2.0 V to 1.8 V in the test conditions for the f _{MODOSC} /dV _{CC} parameter in † 8.12.3.6, <i>Module Oscillator (MODOSC)</i> | . 24 |
| • | Corrected bitfield from RTCCLK to RTCCKSEL in table note that starts "Controlled by" in 表 9-8, Clock | .44 |
| • | Corrected bitfield from IRDSEL to IRDSSEL in † 9.10.8, <i>Timers (Timer0_A3, Timer1_A3)</i> , in the description that starts "The interconnection of Timer0 A3 and" | |
| • | Corrected ADCINCHx column heading in 表 9-13, ADC Channel Connections | |
| • | Added P1SELC information in 表 9-28, Port P1, P2 Registers (Base Address: 0200h) | .58 |
| • | Added P2SELC information in 表 9-28, Port P1, P2 Registers (Base Address: 0200h) | .58 |
| | | |

6 Device Comparison

8pt 6-1 summarizes the features of the available family members.

表 6-1. Device Comparison

| DEVICE ⁽¹⁾ | PROGRAM FRAM + INFORMATION FRAM (bytes) | SRAM (bytes) | TA0,TA1 | eUSCI_A | eUSCI_B | 10-BIT ADC CHANNELS | GPIOs | PACKAGE ⁽²⁾ |
|-----------------------|---|-----------------|---------------------------|---------|---------|------------------------|-------|------------------------|
| MSP430FR2422IRHL | 7424 + 256 | 2048 | 2, 3 × CCR ⁽³⁾ | 1 | 1 | 8 | 15 | 20 RHL (VQFN) |
| MSP430FR2422IPW16 | 7424 + 256 | 2048 | 2, 3 × CCR ⁽³⁾ | 1 | 1 | 5 | 11 | 16 PW (TSSOP) |

- (1) For the most current package and ordering information, see the *Package Option Addendum* in 节 12, or see the TI website at www.ti.com.
- (2) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/packaging.
- (3) A CCR register is a configurable register that provides internal and external capture or compare inputs, or internal and external PWM outputs.

6.1 Related Products

For information about other devices in this family of products or related products, see the following links.

TI 16-bit and 32-bit microcontrollers

High-performance, low-power solutions to enable the autonomous future

Products for MSP430 ultra-low-power sensing and measurement microcontrollers

One platform. One ecosystem. Endless possibilities.

Companion Products for MSP430FR2422

Review products that are frequently purchased or used in conjunction with this product.

Reference Designs

Find reference designs leveraging the best in TI technology to solve your system-level challenges

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7 Terminal Configuration and Functions7.1 Pin Diagrams

图 7-1 shows the pinout of the 20-pin RHL package.

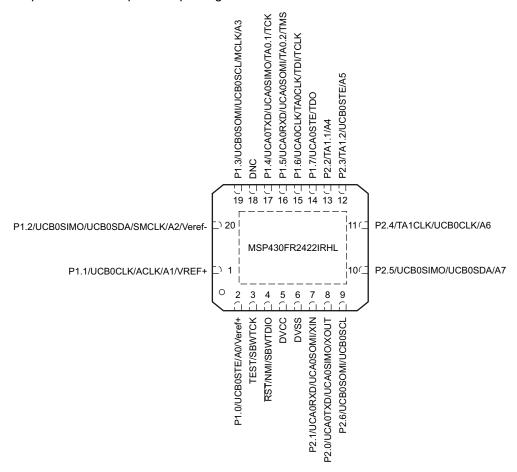


图 7-1. 20-Pin RHL Package (Top View)

图 7-2 shows the pinout of the 16-pin PW package.

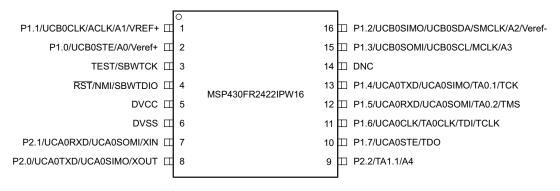


图 7-2. 16-Pin PW Package (Top View)



7.2 Pin Attributes

表 7-1 lists the attributes of all pins.

表 7-1. Pin Attributes

| 表 7-1. Pin Attributes | | | | | | | |
|-----------------------|---------------|--------------------|-------------------------------|----------------|-----------------|---|--|
| PIN NU | JMBER PW16 | SIGNAL NAME(1) (4) | SIGNAL TYPE ⁽²⁾ | BUFFER TYPE(3) | POWER SOURCE(5) | RESET STATE AFTER BOR ⁽⁶⁾ | |
| | | P1.1 (RD) | I/O | LVCMOS | DVCC | OFF | |
| | | UCB0CLK | I/O | LVCMOS | DVCC | _ | |
| 1 | 1 | ACLK | I/O | LVCMOS | DVCC | _ | |
| | | A1 | I | Analog | DVCC | _ | |
| | | VREF+ | I | Analog | Power | _ | |
| | | P1.0 (RD) | I/O | LVCMOS | DVCC | OFF | |
| | | UCB0STE | I/O | LVCMOS | DVCC | _ | |
| 2 | 2 | A0 | I | Analog | DVCC | - | |
| | | Veref+ | I | Analog | Power | - | |
| | | TEST (RD) | I | LVCMOS | DVCC | OFF | |
| 3 | 3 | SBWTCK | I | LVCMOS | DVCC | - | |
| | | RST (RD) | I | LVCMOS | DVCC | OFF | |
| 4 | 4 | NMI | I | LVCMOS | DVCC | - | |
| | | SBWTDIO | I/O | LVCMOS | DVCC | - | |
| 5 | 5 | DVCC | Р | Power | DVCC | N/A | |
| 6 | 6 | DVSS | Р | Power | DVCC | N/A | |
| | 7 | P2.1 (RD) | I/O | LVCMOS | DVCC | OFF | |
| _ | | UCA0RXD | I | LVCMOS | DVCC | _ | |
| 7 | | UCA0SOMI | I/O | LVCMOS | DVCC | - | |
| | | XIN | I | LVCMOS | DVCC | - | |
| | | P2.0 (RD) | I/O | LVCMOS | DVCC | OFF | |
| | | UCA0TXD | 0 | LVCMOS | DVCC | - | |
| 8 | 8 | UCA0SIMO | I/O | LVCMOS | DVCC | - | |
| | | XOUT | 0 | LVCMOS | DVCC | - | |
| | | P2.6 (RD) | I/O | LVCMOS | DVCC | OFF | |
| 9 | - | UCB0SOMI | I/O | LVCMOS | DVCC | - | |
| | | UCB0SCL | I/O | LVCMOS | DVCC | - | |
| | | P2.5 (RD) | I/O | LVCMOS | DVCC | OFF | |
| 40 | | UCB0SIMO | I/O | LVCMOS | DVCC | - | |
| 10 | _ | UCB0SDA | I/O | LVCMOS | DVCC | - | |
| | | A7 | I | Analog | DVCC | - | |
| | | P2.4 (RD) | I/O | LVCMOS | DVCC | OFF | |
| 44 | | TA1CLK | I | LVCMOS | DVCC | - | |
| 11 | _ | UCB0CLK | I/O | LVCMOS | DVCC | - | |
| | | A6 | I | Analog | DVCC | - | |
| | | P2.3 (RD) | I/O | LVCMOS | DVCC | OFF | |
| 10 | | TA1.2 | I/O | LVCMOS | DVCC | - | |
| 12 | _ | UCB0STE | I/O | LVCMOS | DVCC | - | |
| | | A5 | I | Analog | DVCC | - | |



表 7-1. Pin Attributes (continued)

| PIN NUMBER | | SIGNAL NAME(1) (4) | SIGNAL | DUEEED TYPE(3) | POWER SOURCE(5) | RESET STATE |
|------------|------|--------------------|---------------------|----------------------------|-----------------|--------------------------|
| RHL | PW16 | SIGNAL NAME(1) (4) | TYPE ⁽²⁾ | BUFFER TYPE ⁽³⁾ | POWER SOURCE(*) | AFTER BOR ⁽⁶⁾ |
| | | P2.2 (RD) | I/O | LVCMOS | DVCC | OFF |
| 13 | 9 | TA1.1 | I/O | LVCMOS | DVCC | - |
| | | A4 | I | Analog | DVCC | - |
| | | P1.7 (RD) | I/O | LVCMOS | DVCC | OFF |
| 14 | 10 | UCA0STE | I/O | LVCMOS | DVCC | - |
| | | TDO | 0 | LVCMOS | DVCC | - |
| | | P1.6 (RD) | I/O | LVCMOS | DVCC | OFF |
| | | UCA0CLK | I/O | LVCMOS | DVCC | - |
| 15 | 11 | TA0CLK | I | LVCMOS | DVCC | - |
| | | TDI | I | LVCMOS | DVCC | - |
| | | TCLK | I | LVCMOS | DVCC | - |
| | | P1.5 (RD) | I/O | LVCMOS | DVCC | OFF |
| | | UCA0RXD | I | LVCMOS | DVCC | - |
| 16 | 12 | UCA0SOMI | I/O | LVCMOS | DVCC | - |
| | | TA0.2 | I/O | LVCMOS | DVCC | - |
| | | TMS | I | LVCMOS | DVCC | - |
| | | P1.4 (RD) | I/O | LVCMOS | DVCC | OFF |
| | | UCA0TXD | 0 | LVCMOS | DVCC | - |
| 17 | 13 | UCA0SIMO | I/O | LVCMOS | DVCC | - |
| | | TA0.1 | I/O | LVCMOS | DVCC | - |
| | | TCK | I | LVCMOS | DVCC | - |
| 18 | 14 | DNC | - | - | - | - |
| | | P1.3 (RD) | I/O | LVCMOS | DVCC | OFF |
| | | UCB0SOMI | I/O | LVCMOS | DVCC | - |
| 19 | 15 | UCB0SCL | I/O | LVCMOS | DVCC | - |
| | | MCLK | 0 | LVCMOS | DVCC | - |
| | | A3 | I | Analog | DVCC | - |
| | | P1.2 (RD) | I/O | LVCMOS | DVCC | OFF |
| | | UCB0SIMO | I/O | LVCMOS | DVCC | - |
| 20 | 16 | UCB0SDA | I/O | LVCMOS | DVCC | - |
| 20 | 16 | SMCLK | 0 | LVCMOS | DVCC | - |
| | | A2 | I | Analog | DVCC | - |
| | | Veref- | I | Analog | Power | - |
| | | | | | | |

- (1) Signals names with (RD) denote the reset default pin name.
- (2) Signal Types: I = Input, O = Output, I/O = Input or Output
- (3) Buffer Types: LVCMOS, Analog, or Power (see 表 7-3)
- (4) To determine the pin mux encodings for each pin, see \ddagger 9.11.
- (5) The power source shown in this table is the I/O power source, which may differ from the module power source.
- (6) Reset States:

OFF = High-impedance with Schmitt trigger and pullup or pulldown (if available) disabled

N/A = Not applicable



7.3 Signal Descriptions

 ${\ensuremath{\,\overline{\, \hbox{$\,\overline{\,}}}}}$ 7-2 describes the signals for all device variants and package options.

表 7-2. Signal Descriptions

| 表 7-2. Signal Descriptions | | | | | | | | |
|----------------------------|-------------|--------|----|----------------------------|---|--|--|--|
| FUNCTION | SIGNAL NAME | PIN NU | | PIN TYPE ⁽¹⁾ | DESCRIPTION | | | |
| | 100 | RHL | PW | - | | | | |
| | A0 | 2 | 2 | l l | Analog input A0 | | | |
| | A1 | 1 | 1 | 1 | Analog input A1 | | | |
| | A2 | 20 | 16 | l I | Analog input A2 | | | |
| | A3 | 19 | 15 | I | Analog input A3 | | | |
| ADC | A4 | 13 | 9 | I | Analog input A4 | | | |
| | A5 | 12 | - | I | Analog input A5 | | | |
| | A6 | 11 | - | I | Analog input A6 | | | |
| | A7 | 10 | - | I | Analog input A7 | | | |
| | Veref+ | 2 | 2 | I | ADC positive reference | | | |
| | Veref- | 20 | 16 | I | ADC negative reference | | | |
| | ACLK | 1 | 1 | I/O | ACLK output | | | |
| | MCLK | 19 | 15 | 0 | MCLK output | | | |
| Clock | SMCLK | 20 | 16 | 0 | SMCLK output | | | |
| | XIN | 7 | 7 | I | Input terminal for crystal oscillator | | | |
| | XOUT | 8 | 8 | 0 | Output terminal for crystal oscillator | | | |
| | SBWTCK | 3 | 3 | I | Spy-Bi-Wire input clock | | | |
| | SBWTDIO | 4 | 4 | I/O | Spy-Bi-Wire data input/output | | | |
| | TCK | 17 | 13 | I | Test clock | | | |
| | TCLK | 15 | 11 | I | Test clock input | | | |
| Debug | TDI | 15 | 11 | I | Test data input | | | |
| | TDO | 14 | 10 | 0 | Test data output | | | |
| | TEST | 3 | 3 | I | Test mode pin - selected digital I/O on JTAG pins | | | |
| | TMS | 16 | 12 | I | Test mode select | | | |
| | P1.0 | 2 | 2 | I/O | General-purpose I/O | | | |
| | P1.1 | 1 | 1 | I/O | General-purpose I/O | | | |
| | P1.2 | 20 | 16 | I/O | General-purpose I/O | | | |
| | P1.3 | 19 | 15 | I/O | General-purpose I/O | | | |
| | P1.4 | 17 | 13 | I/O | General-purpose I/O ⁽⁴⁾ | | | |
| | P1.5 | 16 | 12 | I/O | General-purpose I/O ⁽⁴⁾ | | | |
| | P1.6 | 15 | 11 | I/O | General-purpose I/O ⁽⁴⁾ | | | |
| GPIO | P1.7 | 14 | 10 | I/O | General-purpose I/O ⁽⁴⁾ | | | |
| | P2.0 | 8 | 8 | I/O | General-purpose I/O | | | |
| | P2.1 | 7 | 7 | I/O | General-purpose I/O | | | |
| | P2.2 | 13 | 9 | I/O | General-purpose I/O | | | |
| | P2.3 | 12 | - | I/O | General-purpose I/O | | | |
| | P2.4 | 11 | - | I/O | General-purpose I/O | | | |
| | P2.5 | 10 | - | I/O | General-purpose I/O | | | |
| | P2.6 | 9 | _ | I/O | General-purpose I/O | | | |
| | 1. =.0 | | | | Tarrian Larkaga na | | | |



表 7-2. Signal Descriptions (continued)

| | | | JMBER | | ptions (continued) |
|------------------|-----------------------------|-----|-------|----------------------------|---|
| FUNCTION | SIGNAL NAME | RHL | PW | PIN TYPE ⁽¹⁾ | DESCRIPTION |
| | UCB0SCL ⁽²⁾ | 19 | 15 | I/O | eUSCI_B0 I ² C clock |
| 120 | UCB0SDA ⁽²⁾ | 20 | 16 | I/O | eUSCI_B0 I ² C data |
| I ² C | UCB0SCL ⁽²⁾ | 9 | - | I/O | eUSCI_B0 I ² C clock |
| | UCB0SDA ⁽²⁾ | 10 | - | I/O | eUSCI_B0 I ² C data |
| | DVCC | 5 | 5 | Р | Power supply |
| Power | DVSS | 6 | 6 | Р | Power ground |
| | VREF+ | 1 | 1 | Р | Output of positive reference voltage with ground as reference |
| | UCA0STE | 14 | 10 | I/O | eUSCI_A0 SPI slave transmit enable |
| | UCA0CLK | 15 | 11 | I/O | eUSCI_A0 SPI clock input/output |
| | UCA0SOMI ⁽²⁾ (3) | 16 | 12 | I/O | eUSCI_A0 SPI slave out/master in |
| | UCA0SIMO ⁽²⁾ (3) | 17 | 13 | I/O | eUSCI_A0 SPI slave in/master out |
| | UCA0SOMI ⁽²⁾ (3) | 7 | 7 | I/O | eUSCI_A0 SPI slave out/master in |
| | UCA0SIMO ^{(2) (3)} | 8 | 8 | I/O | eUSCI_A0 SPI slave in/master out |
| SPI | UCB0STE ⁽²⁾ | 2 | 2 | I/O | eUSCI_B0 slave transmit enable |
| 381 | UCB0CLK ⁽²⁾ | 1 | 1 | I/O | eUSCI_B0 clock input/output |
| | UCB0SOMI ⁽²⁾ | 19 | 15 | I/O | eUSCI_B0 SPI slave out/master in |
| | UCB0SIMO ⁽²⁾ | 20 | 16 | I/O | eUSCI_B0 SPI slave in/master out |
| | UCB0STE ⁽²⁾ | 12 | - | I/O | eUSCI_B0 slave transmit enable |
| | UCB0CLK ⁽²⁾ | 11 | - | I/O | eUSCI_B0 clock input/output |
| | UCB0SOMI ⁽²⁾ | 9 | - | I/O | eUSCI_B0 SPI slave out/master in |
| | UCB0SIMO ⁽²⁾ | 10 | - | I/O | eUSCI_B0 SPI slave in/master out |
| System | NMI | 4 | 4 | I | Nonmaskable interrupt input |
| System | RST | 4 | 4 | I | Active-low reset input |
| | TA0.1 | 17 | 13 | I/O | Timer TA0 CCR1 capture: CCI1A input, compare: Out1 outputs |
| | TA0.2 | 16 | 12 | I/O | Timer TA0 CCR2 capture: CCI2A input, compare: Out2 outputs |
| Timer_A | TA0CLK | 15 | 11 | I | Timer clock input TACLK for TA0 |
| Timer_A | TA1.1 | 13 | 9 | I/O | Timer TA1 CCR1 capture: CCI1A input, compare: Out1 outputs |
| | TA1.2 | 12 | - | I/O | Timer TA1 CCR2 capture: CCI2A input, compare: Out2 outputs |
| | TA1CLK | 11 | - | I | Timer clock input TACLK for TA1 |
| | UCA0RXD ⁽²⁾ | 16 | 12 | I | eUSCI_A0 UART receive data |
| UART | UCA0TXD ⁽²⁾ | 17 | 13 | 0 | eUSCI_A0 UART transmit data |
| UAIXI | UCA0RXD ⁽²⁾ | 7 | 7 | I | eUSCI_A0 UART receive data |
| | UCA0TXD ⁽²⁾ | 8 | 8 | 0 | eUSCI_A0 UART transmit data |
| DNC | Do not connect | 18 | 14 | _ | Do not connect |
| QFN Pad | QFN thermal pad | Pad | - | - | QFN package exposed thermal pad. TI recommends connecting to $\ensuremath{V_{SS}}.$ |

- (1) Pin Types: I = Input, O = Output, I/O = Input or Output, P = Power
- (2) These signal assignments are controlled by the USCIARMP bit of the SYSCFG3 register or the USCIBRMP bit of the SYSCFG2 register. Only one group can be selected at one time.
- (3) Signal assignments on these pins are controlled by the remap functionality and are selected by the USCIARMP bit in the SYSCFG3 register. Only one group can be selected at one time. The CLK and STE assignments are fixed and shared by both SPI function groups.
- (4) Because this pin is multiplexed with the JTAG function, TI recommends disabling the pin interrupt function while in JTAG debug to prevent collisions.

7.4 Pin Multiplexing

Pin multiplexing for this MCU is controlled by both register settings and operating modes (for example, if the MCU is in test mode). For details of the settings for each pin and diagrams of the multiplexed ports, see † 9.11.

7.5 Buffer Types

表 7-3 defines the pin buffer types that are listed in 表 7-1

表 7-3. Buffer Types

| BUFFER TYPE (STANDARD) | NOMINAL VOLTAGE | HYSTERESIS | PU OR PD | NOMINAL PU OR PD STRENGTH (µA) | OUTPUT DRIVE STRENGTH (mA) | OTHER CHARACTERISTICS |
|---------------------------|--------------------|------------------|--------------|---|----------------------------------|--|
| LVCMOS | 3.0 V | Y ⁽¹⁾ | Programmable | See 节 8.12.4 | See 节 8.12.4 | |
| Analog | 3.0 V | N | N/A | N/A | N/A | See analog modules in 节 8 for details. |
| Power (DVCC) | 3.0 V | N | N/A | N/A | N/A | SVS enables hysteresis on DVCC. |
| Power (AVCC) | 3.0 V | N | N/A | N/A | N/A | |

⁽¹⁾ Only for input pins.

7.6 Connection of Unused Pins

表 7-4 lists the correct termination of unused pins.

表 7-4. Connection of Unused Pins

| PIN ⁽¹⁾ | POTENTIAL | COMMENT |
|--------------------|------------------|---|
| Px.0 to Px.7 | Open | Switched to port function, output direction (PxDIR.n = 1) |
| RST/NMI | DV _{CC} | 47-kΩ pullup or internal pullup selected with 10-nF (or 1.1-nF) pulldown ⁽²⁾ |
| TEST | Open | This pin always has an internal pull-down enabled. |

⁽¹⁾ Any unused pin with a secondary function that is shared with general-purpose I/O should follow the Px.0 to Px.7 unused pin connection guidelines.

The pulldown capacitor should not exceed 1.1 nF when using MCUs with Spy-Bi-Wire interface in Spy-Bi-Wire mode with TI tools like

FET interfaces or GANG programmers.



8 Specifications

8.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)

| (1) | MIN | MAX | UNIT |
|--|-------|--------------------------------------|------|
| Voltage applied at DVCC pin to V _{SS} | - 0.3 | 4.1 | V |
| Voltage applied to any other pin ⁽²⁾ | - 0.3 | V _{CC} + 0.3 (4.1 V Max) | V |
| Diode current at any device pin | | ±2 | mA |
| Maximum junction temperature, T _J | | 85 | °C |
| Storage temperature, T _{stg} ⁽³⁾ | - 40 | 125 | °C |

- (1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltages referenced to V_{SS}.
- (3) Higher temperature may be applied during board soldering according to the current JEDEC J-STD-020 specification with peak reflow temperatures not higher than classified on the device label on the shipping boxes or reels.

8.2 ESD Ratings

| | | | VALUE | UNIT |
|--------------------|-------------------------|--|-------|------|
| V _(ESD) | Electrostatic discharge | Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾ | ±1000 | V |
| | Liectiostatic discharge | Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾ | ±250 | |

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process. Pins listed as ±1000 V may actually have higher performance.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process. Pins listed as ±250 V may actually have higher performance.

8.3 Recommended Operating Conditions

| | | | MIN | NOM | MAX | UNIT |
|---------------------|--|--|------|-----|-------------------|--------|
| V _{CC} | Supply voltage applied at DVCC pin ⁽¹⁾ (2) (3) (4) | | 1.8 | | 3.6 | V |
| V _{SS} | Supply voltage applied at DVSS pin | | | 0 | | ٧ |
| T _A | Operating free-air temperature | | - 40 | | 85 | °C |
| TJ | Operating junction temperature | - 40 | | 85 | °C | |
| C _{DVCC} | Recommended capacitor at DVCC ⁽⁵⁾ | | 4.7 | 10 | | μF |
| | December from the street from the street was MOLIV from the street (A) (7) | No FRAM wait states (NWAITSx = 0) | 0 | | 8 | NAL 1- |
| f _{SYSTEM} | Processor frequency (maximum MCLK frequency) ^{(4) (7)} | With FRAM wait states (NWAITSx = 1) ⁽⁶⁾ | 0 | | 16 ⁽⁸⁾ | MHz |
| f _{ACLK} | Maximum ACLK frequency | | | | 40 | kHz |
| f _{SMCLK} | Maximum SMCLK frequency | | | | 16 ⁽⁸⁾ | MHz |

- (1) Supply voltage changes faster than 0.2 V/μs can trigger a BOR reset even within the recommended supply voltage range. Following the data sheet recommendation for capacitor C_{DVCC} limits the slopes accordingly.
- (2) Modules may have a different supply voltage range specification. See the specification of the respective module in this data sheet.
- (3) TI recommends that power to the DVCC pin must not exceed the limits specified in *Recommended Operating Conditions*. Exceeding the specified limits can cause malfunction of the device including erroneous writes to RAM and FRAM.
- (4) The minimum supply voltage is defined by the SVS levels. See the SVS threshold parameters in † 8.12.1.1.
- (5) A capacitor tolerance of ±20% or better is required. A low-ESR ceramic capacitor of 100 nF (minimum) should be placed as close as possible (within a few millimeters) to the respective pin pair.
- (6) Wait states only occur on actual FRAM accesses (that is, on FRAM cache misses). RAM and peripheral accesses are always executed without wait states.
- (7) Modules may have a different maximum input clock specification. See the specification of the respective module in this data sheet.
- (8) If clock sources such as HF crystals or the DCO with frequencies >16 MHz are used, the clock must be divided in the clock system to comply with this operating condition.

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8.4 Active Mode Supply Current Into V_{CC} Excluding External Current

See (1)

| | | | | FRE | QUENCY (f _M | _{CLK} = f _{SN} | ICLK) | | | |
|-------------------------------------|----------------------|-------------------|---|-----|---|----------------------------------|---|------|------|--|
| PARAMETER | EXECUTION MEMORY | TEST CONDITION | 1 MHz 0 WAIT STATES (NWAITSx = 0) | | 8 MHz 0 WAIT STATES (NWAITSx = 0) | | 16 MHz 1 WAIT STATE (NWAITSx = 1) | | UNIT | |
| | | | | TYP | MAX | TYP | MAX | TYP | MAX | |
| 1(0%) | FRAM | 3 V, 25°C | 454 | | 2620 | | 2935 | | μA | |
| I _{AM, FRAM} (0%) | 0% cache hit ratio | 3 V, 85°C | 471 | | 2700 | | 2980 | 3250 | μΑ | |
| (4000/) | FRAM | 3 V, 25°C | 191 | | 573 | | 950 | | | |
| I _{AM, FRAM} (100%) | 100%) ache hit ratio | 3 V, 85°C | 199 | | 592 | | 974 | 1200 | μA | |
| I _{AM, RAM} ⁽²⁾ | RAM | 3 V, 25°C | 216 | | 772 | | 1300 | | μΑ | |

⁽¹⁾ All inputs are tied to 0 V or to V_{CC}. Outputs do not source or sink any current. Characterized with program executing typical data processing.

8.5 Active Mode Supply Current Per MHz

V_{CC} = 3 V, T_A = 25°C (unless otherwise noted)

| | PARAMETER | TEST CONDITIONS | TYP | UNIT |
|---------------------------|-----------|--|-----|--------|
| dl _{AM,FRAM} /df | | [I _{AM} (75% cache hit rate) at 8 MHz - I _{AM} (75% cache hit rate) at 1 MHz) / 7 MHz | 120 | μΑ/MHz |

8.6 Low-Power Mode (LPM0) Supply Currents Into V_{CC} Excluding External Current

 $V_{CC} = 3 \text{ V}, T_A = 25^{\circ}\text{C} \text{ (unless otherwise noted)}^{(1)}$ (2)

| | | FREQUENCY (f _{SMCLK}) | | | | | | |
|-----------|-----------------|---------------------------------|-----|-------|-----|--------|-----|------|
| PARAMETER | V _{CC} | 1 MHz | | 8 MHz | | 16 MHz | | UNIT |
| | | TYP | MAX | TYP | MAX | TYP | MAX | |
| | 2 V | 145 | | 292 | | 395 | | μA |
| ILPM0 | 3 V | 155 | | 300 | | 394 | | μΑ |

⁽¹⁾ All inputs are tied to 0 V or to V_{CC}. Outputs do not source or sink any current.

f_{ACLK} = 32768 Hz, f_{MCLK} = f_{SMCLK} = f_{DCO} at specified frequency Program and data entirely reside in FRAM. All execution is from FRAM.

⁽²⁾ Program and data reside entirely in RAM. All execution is from RAM. No access to FRAM.

⁽²⁾ Current for watchdog timer clocked by SMCLK included.

 f_{ACLK} = 32768 Hz, f_{MCLK} = 0 MHz, f_{SMCLK} at specified frequency.



8.7 Low-Power Mode (LPM3, LPM4) Supply Currents (Into V_{CC}) Excluding External Current

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (1)

| | PARAMETER | V _{cc} | - 40 | °C | 25° | С | 85° | С | UNIT |
|-------------------------|--|-----------------|------|-----|------|-----|------|-----|------|
| | FARAWETER | V CC | TYP | MAX | TYP | MAX | TYP | MAX | ONII |
| | Low-power mode 3, 12.5-pF crystal, includes | 3 V | 0.96 | | 1.11 | | 2.75 | 6.2 | μA |
| LPM3,XT1 | SVS ^{(2) (3) (4)} | 2 V | 0.93 | | 1.08 | | 2.78 | | μΛ |
| 1 | Low-power mode 3, VLO, excludes SVS ⁽⁵⁾ | 3 V | 0.77 | | 0.92 | | 2.66 | 6.0 | |
| I _{LPM3,VLO} | Low-power mode 3, VLO, excludes 3V3 | 2 V | 0.75 | | 0.90 | | 2.60 | | μA |
| I _{LPM3, RTC} | Low-power mode 3, RTC, excludes SVS ⁽⁹⁾ | 3 V | 0.90 | | 1.05 | | 2.77 | | μA |
| | Low-power mode 4, includes SVS ⁽⁶⁾ | 3 V | 0.51 | | 0.64 | | 2.30 | | |
| I _{LPM4} , SVS | | 2 V | 0.49 | | 0.61 | | 2.25 | | - μΑ |
| 1 | Low-power mode 4, excludes SVS ⁽⁶⁾ | 3 V | 0.35 | | 0.48 | | 2.13 | | |
| I _{LPM4} | Low-power mode 4, excludes 3 v 3 v | 2 V | 0.34 | | 0.46 | | 2.10 | | μA |
| | Low-power mode 4, RTC is soured from VLO, | 3 V | 0.43 | | 0.56 | | 2.21 | | |
| LPM4,VLO | excludes SVS ⁽⁷⁾ | 2 V | 0.42 | | 0.55 | | 2.19 | | μA |
| | Low-power mode 4, RTC is soured from XT1, | 3 V | 0.80 | | 0.96 | | 2.68 | | |
| ILPM4,XT1 | excludes SVS ⁽⁸⁾ | 2 V | 0.79 | | 0.94 | | 2.64 | | μA |

- (1) All inputs are tied to 0 V or to V_{CC}. Outputs do not source or sink any current.
- (2) Not applicable for MCUs with HF crystal oscillator only.
- (3) Characterized with a Seiko Crystal SC-32S crystal with a load capacitance chosen to closely match the required load.
- (4) Low-power mode 3, 12.5-pF crystal, includes SVS test conditions:
 Current for watchdog timer clocked by ACLK and RTC clocked by XT1 included. Current for brownout and SVS included (SVSHE = 1).
 CPUOFF = 1, SCG0 = 1 SCG1 = 1, OSCOFF = 0 (LPM3),
 f_{XT1} = 32768 Hz, f_{ACLK} = f_{XT1}, f_{MCLK} = f_{SMCLK} = 0 MHz

 (5) Low-power mode 3, VLO, excludes SVS test conditions:
- (5) Low-power mode 3, VLO, excludes SVS test conditions: Current for watchdog timer clocked by VLO included. RTC disabled. Current for brownout included. SVS disabled (SVSHE = 0). CPUOFF = 1, SCG0 = 1 SCG1 = 1, OSCOFF = 0 (LPM3) f_{XT1} = 32768 Hz, f_{ACLK} = f_{MCLK} = f_{SMCLK} = 0 MHz
- (6) Low-power mode 4, CPUOFF = 1, SCG0 = 1 SCG1 = 1, OSCOFF = 1 (LPM4), CPU and all clocks are disabled, WDT and RTC disabled
- (7) Low-power mode 4, VLO, excludes SVS test conditions: Current for RTC clocked by VLO included. Current for brownout included. SVS disabled (SVSHE = 0). CPUOFF = 1, SCG0 = 1 SCG1 = 1, OSCOFF = 1 (LPM4) $f_{XT1} = 0$ Hz, $f_{MCLK} = f_{SMCLK} = 0$ MHz
- (8) Low-power mode 4, XT1, excludes SVS test conditions:

 Current for RTC clocked by XT1 included. Current for brownout included. SVS disabled (SVSHE = 0).

 CPUOFF = 1, SCG0 = 1 SCG1 = 1, OSCOFF = 1 (LPM4)

 f_{XT1} = 32768 Hz, f_{MCLK} = f_{SMCLK} = 0 MHz
- (9) RTC periodically wakes up every second with external 32768-Hz input as source.

8.8 Low-Power Mode (LPMx.5) Supply Currents (Into V_{CC}) Excluding External Current

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| | PARAMETER | V _{cc} | - 40 | °C | 25° | С | 85° | С | UNIT |
|--------------------------|---|-----------------|-------|-----|-------|-----|-------|------|------|
| | PANAMETER | ♥cc | TYP | MAX | TYP | MAX | TYP | MAX | |
| I _{LPM3.5, XT1} | Low-power mode 3.5, 12.5-pF crystal, includes | 3 V | 0.57 | | 0.63 | | 0.81 | 1.54 | |
| | SVS ⁽¹⁾ (2) (3) (also see 图 8-3) | 2 V | 0.54 | | 0.60 | | 0.79 | | μA |
| ı | Low-power mode 4.5, includes SVS ⁽⁴⁾ | 3 V | 0.23 | | 0.25 | | 0.31 | 0.45 | μA |
| ILPM4.5, SVS | | 2 V | 0.21 | | 0.23 | | 0.29 | | μΑ |
| 1 | Low-power mode 4.5, excludes SVS ⁽⁵⁾ | 3 V | 0.027 | | 0.036 | | 0.080 | 0.15 | |
| ILPM4.5 | | 2 V | 0.022 | | 0.031 | | 0.073 | | μΑ |

- (1) Not applicable for MCUs with HF crystal oscillator only.
- (2) Characterized with a Seiko Crystal SC-32S crystal with a load capacitance chosen to closely match the required load.
- Low-power mode 3.5, 12.5-pF crystal, includes SVS test conditions:

 Current for RTC clocked by XT1 included. Current for brownout and SVS included (SVSHE = 1). Core regulator disabled.
 PMMREGOFF = 1, CPUOFF = 1, SCG0 = 1 SCG1 = 1, OSCOFF = 1 (LPMx.5),

 fxt1 = 32768 Hz. factic = 0, factic = 0 MHz
- $f_{XT1} = 32768 \text{ Hz, } f_{ACLK} = 0, f_{MCLK} = f_{SMCLK} = 0 \text{ MHz}$ $(4) \quad \text{Low-power mode 4.5, includes SVS test conditions:}$ Current for brownout and SVS included (SVSHE = 1). Core regulator disabled. PMMREGOFF = 1, CPUOFF = 1, SCG0 = 1 SCG1 = 1, OSCOFF = 1 (LPMx.5) $f_{XT1} = 0 \text{ Hz, } f_{ACLK} = f_{MCLK} = f_{SMCLK} = 0 \text{ MHz}$
- (5) Low-power mode 4.5, excludes SVS test conditions:

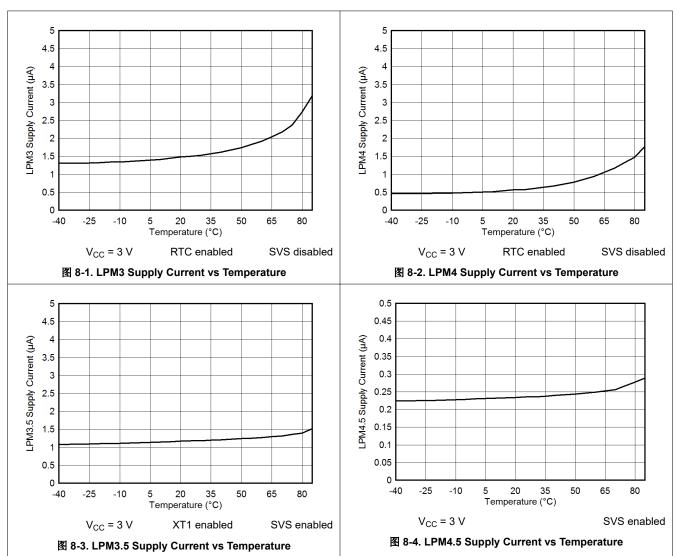
 Current for brownout included. SVS disabled (SVSHE = 0). Core regulator disabled.

 PMMREGOFF = 1, CPUOFF = 1, SCG0 = 1 SCG1 = 1, OSCOFF = 1 (LPMx.5)

 f_{XT1} = 0 Hz, f_{ACLK} = f_{MCLK} = f_{SMCLK} = 0 MHz



8.9 Typical Characteristics - Low-Power Mode Supply Currents



8.10 Typical Characteristics - Current Consumption Per Module

| MODULE | TEST CONDITIONS | REFERENCE CLOCK | MIN | TYP MA | X UNIT |
|---------|----------------------------------|--------------------|-----|--------|--------|
| Timer_A | | Module input clock | | 5 | μA/MHz |
| eUSCI_A | UART mode | Module input clock | | 7 | μA/MHz |
| eUSCI_A | SPI mode | Module input clock | | 5 | μA/MHz |
| eUSCI_B | SPI mode | Module input clock | | 5 | μA/MHz |
| eUSCI_B | I ² C mode, 100 kbaud | Module input clock | | 5 | μA/MHz |
| RTC | | 32 kHz | | 85 | nA |
| CRC | From start to end of operation | MCLK | | 8.5 | μA/MHz |

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8.11 Thermal Resistance Characteristics

| | THERMAL METRIC(1) | | VALUE ⁽²⁾ | UNIT |
|----------------------|---|---------------------|----------------------|--------|
| D A | Junction-to-ambient thermal resistance, still air | VQFN 20 pin (RHL) | 37.8 | °C/W |
| Rθ _{JA} Jur | Junction-to-amplent thermal resistance, still all | TSSOP 16 pin (PW16) | 101.7 | - C/VV |
| R θ JC | Junction-to-case (top) thermal resistance | VQFN 20 pin (RHL) | 34.1 | °C/W |
| | | TSSOP 16 pin (PW16) | 33.7 | - C/VV |
| D A | Junction-to-board thermal resistance | VQFN 20 pin (RHL) | 15.3 | °C/W |
| R θ _{JB} | | TSSOP 16 pin (PW16) | 47.5 | - C/VV |

- (1) For more information about traditional and new thermal metrics, see Semiconductor and IC Package Thermal Metrics.
- (2) These values are based on a JEDEC-defined 2S2P system (with the exception of the Theta JC (R θ _{JC}) value, which is based on a JEDEC-defined 1S0P system) and will change based on environment and application. For more information, see these EIA/JEDEC standards:
 - · JESD51-2, Integrated Circuits Thermal Test Method Environmental Conditions Natural Convection (Still Air)
 - JESD51-3, Low Effective Thermal Conductivity Test Board for Leaded Surface Mount Packages
 - JESD51-7, High Effective Thermal Conductivity Test Board for Leaded Surface Mount Packages
 - JESD51-9, Test Boards for Area Array Surface Mount Package Thermal Measurements

8.12 Timing and Switching Characteristics

8.12.1 Power Supply Sequencing

节 8.12.1.1 lists the characteristics of the SVS and BOR.

8.12.1.1 PMM, SVS and BOR

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| | PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|------------------------------|---|-------------------------|------|------|------|------|
| V _{BOR, safe} | Safe BOR power-down level ⁽¹⁾ | | 0.1 | | | V |
| t _{BOR, safe} | Safe BOR reset delay ⁽²⁾ | | 10 | | | ms |
| I _{SVSH,AM} | SVS _H current consumption, active mode | V _{CC} = 3.6 V | | | 1.5 | μA |
| I _{SVSH,LPM} | SVS _H current consumption, low-power modes | V _{CC} = 3.6 V | | 240 | | nA |
| V _{SVSH-} | SVS _H power-down level ⁽³⁾ | | 1.71 | 1.80 | 1.87 | V |
| V _{SVSH+} | SVS _H power-up level ⁽³⁾ | | 1.76 | 1.88 | 1.99 | V |
| V _{SVSH_hys} | SVS _H hysteresis | | | 80 | | mV |
| t _{PD,SVSH, AM} | SVS _H propagation delay, active mode | | | | 10 | μs |
| t _{PD,SVSH,} LPM | SVS _H propagation delay, low-power modes | | | | 100 | μs |

- (1) A safe BOR can be correctly generated only if DVCC drops below this voltage before it rises.
- (2) When an BOR occurs, a safe BOR can be correctly generated only if DVCC is kept low longer than this period before it reaches
- (3) For additional information, see the Dynamic Voltage Scaling Power Solution for MSP430 Devices With Single-Channel LDO Reference Design.

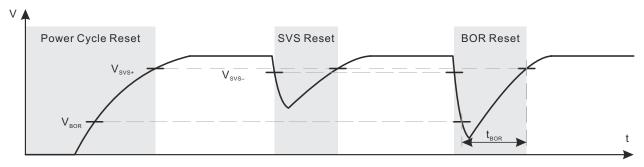


图 8-5. Power Cycle, SVS, and BOR Reset Conditions



8.12.2 Reset Timing

节 8.12.2.1 lists the timing characteristics of wakeup from LPMs and reset.

8.12.2.1 Wake-up Times From Low-Power Modes and Reset

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| | PARAMETER | TEST CONDITIONS | V _{cc} | MIN | TYP | MAX | UNIT |
|-----------------------------|--|--------------------|-----------------|-----|-----|---------------------------------|------|
| t _{WAKE-UP} FRAM | Additional wake-up time to activate the FRAM in AM if previously disabled by the FRAM controller or from a LPM if immediate activation is selected for wakeup ⁽¹⁾ | | 3 V | | 10 | | μs |
| t _{WAKE-UP LPM0} | Wake-up time from LPM0 to active mode (1) | | 3 V | | | 200 + 2.5 / f _{DCO} | ns |
| t _{WAKE-UP LPM3} | Wake-up time from LPM3 to active mode (2) | | 3 V | | 10 | | μs |
| t _{WAKE-UP LPM4} | Wake-up time from LPM4 to active mode | | 3 V | | 10 | | μs |
| t _{WAKE-UP} LPM3.5 | Wake-up time from LPM3.5 to active mode (2) | | 3 V | | 350 | | μs |
| + | Wake-up time from LPM4.5 to active mode (2) | SVSHE = 1 | 3 V | | 350 | | μs |
| t _{WAKE-UP} LPM4.5 | wake-up time from LPIW4.5 to active mode (-) | SVSHE = 0 | 3 V | | 1 | | ms |
| t _{WAKE-UP-RESET} | Wake-up time from RST or BOR event to active mode (2) | | 3 V | | 1 | | ms |
| t _{RESET} | Pulse duration required at RST/NMI pin to accept a reset | | 3 V | 2 | | | μs |

⁽¹⁾ The wake-up time is measured from the edge of an external wake-up signal (for example, port interrupt or wake-up event) to the first externally observable MCLK clock edge.

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⁽²⁾ The wake-up time is measured from the edge of an external wake-up signal (for example, port interrupt or wake-up event) until the first instruction of the user program is executed.

8.12.3 Clock Specifications

节 8.12.3.1 lists the characteristics of the LF XT1.

8.12.3.1 XT1 Crystal Oscillator (Low Frequency)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)⁽¹⁾ (2)

| | PARAMETER | TEST CONDITIONS | V _{cc} | MIN T | P MAX | UNIT |
|-------------------------|--|--|-----------------|-------|-------|------|
| f _{XT1, LF} | XT1 oscillator crystal, low frequency | LFXTBYPASS = 0 | | 327 | 68 | Hz |
| DC _{XT1, LF} | XT1 oscillator LF duty cycle | Measured at MCLK, f _{LFXT} = 32768 Hz | | 30% | 70% | |
| f _{XT1,SW} | XT1 oscillator logic-level square- wave input frequency | LFXTBYPASS = 1 (3) (4) | | 32.7 | 68 | kHz |
| DC _{XT1, SW} | LFXT oscillator logic-level square-wave input duty cycle | LFXTBYPASS = 1 | | 40% | 60% | |
| OA _{LFXT} | Oscillation allowance for LF crystals ⁽⁵⁾ | | | 2 | 00 | kΩ |
| $C_{L,eff}$ | Integrated effective load capacitance ⁽⁶⁾ | See ⁽⁷⁾ | | | 1 | pF |
| t _{START,LFXT} | Start-up time ⁽⁹⁾ | f_{OSC} = 32768 Hz, LFXTBYPASS = 0, LFXTDRIVE = {3}, T_A = 25°C, $C_{L,eff}$ = 12.5 pF | | 10 | 00 | ms |
| f _{Fault,LFXT} | Oscillator fault frequency (10) | XTS = 0 ⁽⁸⁾ | | 0 | 3500 | Hz |

- (1) To improve EMI on the LFXT oscillator, observe the following guidelines:
 - Keep the trace between the device and the crystal as short as possible.
 - · Design a good ground plane around the oscillator pins.
 - Prevent crosstalk from other clock or data lines into oscillator pins XIN and XOUT.
 - · Avoid running PCB traces underneath or adjacent to the XIN and XOUT pins.
 - Use assembly materials and processes that avoid any parasitic load on the oscillator XIN and XOUT pins.
 - If conformal coating is used, make sure that it does not induce capacitive or resistive leakage between the oscillator pins.
- (2) See MSP430 32-kHz Crystal Oscillators for details on crystal section, layout, and testing.
- (3) When LFXTBYPASS is set, LFXT circuits are automatically powered down. Input signal is a digital square wave with parametrics defined in the Schmitt-trigger inputs section of this data sheet. Duty cycle requirements are defined by DC_{LFXT, SW}.
- (4) Maximum frequency of operation of the entire device cannot be exceeded.
- (5) Oscillation allowance is based on a safety factor of 5 for recommended crystals. The oscillation allowance is a function of the LFXTDRIVE settings and the effective load. In general, comparable oscillator allowance can be achieved based on the following guidelines, but should be evaluated based on the actual crystal selected for the application:
 - For LFXTDRIVE = {0}, C_{L,eff} = 3.7 pF
 - For LFXTDRIVE = {1}, 6 pF \leq C_{L,eff} \leq 9 pF
 - For LFXTDRIVE = {2}, 6 pF \leq C_{L,eff} \leq 10 pF
 - For LFXTDRIVE = {3}, 6 pF \leq C_{L.eff} \leq 12 pF
- (6) Includes parasitic bond and package capacitance (approximately 2 pF per pin).
- (7) Requires external capacitors at both terminals to meet the effective load capacitance specified by crystal manufacturers. Recommended effective load capacitance values supported are 3.7 pF, 6 pF, 9 pF, and 12.5 pF. Maximum shunt capacitance of 1.6 pF. The PCB adds additional capacitance, so it must also be considered in the overall capacitance. Verify that the recommended effective load capacitance of the selected crystal is met.
- (8) Measured with logic-level input frequency but also applies to operation with crystals.
- (9) Includes start-up counter of 1024 clock cycles.
- (10) Frequencies above the MAX specification do not set the fault flag. Frequencies between the MIN and MAX specifications might set the flag. A static condition or stuck at fault condition sets the flag.

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8.12.3.2 DCO FLL, Frequency

over recommended operating free-air temperature (unless otherwise noted)

| | PARAMETER | TEST CONDITIONS | V _{cc} | MIN | TYP | MAX | UNIT |
|------------------------|--|--|-----------------|--------|--------|------|------|
| | FLL lock frequency, 16 MHz, 25°C | Measured at MCLK, Internal | 3 V | - 1.0% | | 1.0% | |
| f _{DCO. FLL} | FLL lock frequency, 16 MHz, - 40°C to 85°C | trimmed REFO as reference | 3 V | - 2.0% | | 2.0% | |
| -bco, FLL | FLL lock frequency, 16 MHz, - 40°C to 85°C | Measured at MCLK, XT1 crystal as reference | 3 V | - 0.5% | | 0.5% | |
| f _{DUTY} | Duty cycle | | 3 V | 40% | 50% | 60% | |
| Jitter _{cc} | Cycle-to-cycle jitter, 16 MHz | Measured at MCLK, XT1 | 3 V | | 0.25% | | |
| Jitter _{long} | Long term jitter, 16 MHz | crystal as reference | 3 V | | 0.022% | | |
| t _{FLL, lock} | FLL lock time, 16MHz | | 3 V | | 280 | | ms |

节 8.12.3.3 lists the characteristics of the DCO.

8.12.3.3 DCO Frequency

over recommended operating free-air temperature (unless otherwise noted) (see 图 8-6)

| | PARAMETER | TEST CONDITIONS | V _{cc} | TYP | UNIT |
|-------------------------|----------------------------|--|-----------------|------|---------|
| | | DCORSEL = 101b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 000b, DCO = 0 | | 7.1 | |
| f | DCO frequency, 16 MHz | DCORSEL = 101b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 000b, DCO = 511 | 3 V | 11.8 | MHz |
| [†] DCO, 16MHz | DGG frequency, 10 Miliz | DCORSEL = 101b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 111b, DCO = 0 | | 17 | IVII IZ |
| | | DCORSEL = 101b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 111b, DCO = 511 | | 27.7 | |
| | | DCORSEL = 100b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 000b, DCO = 0 | | 5.5 | |
| f _{DCO, 12MHz} | DCO frequency, 12 MHz | DCORSEL = 100b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 000b, DCO = 511 | 3 V | 9.1 | MHz |
| | DOO II EQUEINOY, 12 WII 12 | DCORSEL = 100b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 111b, DCO = 0 | | 13.1 | 1711 12 |
| | | DCORSEL = 100b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 111b, DCO = 511 | | 21.5 | |
| | 5001 | DCORSEL = 011b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 000b, DCO = 0 | | 3.7 | MHz |
| f | | DCORSEL = 011b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 000b, DCO = 511 | 3 V | 6.3 | |
| f _{DCO, 8MHz} | DCO frequency, 8 MHz | DCORSEL = 011b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 111b, DCO = 0 | 3 V | 9.0 | |
| | | DCORSEL = 011b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 111b, DCO = 511 | | 14.9 | |
| | | DCORSEL = 010b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 000b, DCO = 0 | | 1.9 | |
| £ | DCO fraguanay 4 MU- | DCORSEL = 010b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 000b, DCO = 511 | 3 V | 3.2 | MHz |
| f _{DCO, 4MHz} | DCO frequency, 4 MHz | DCORSEL = 010b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 111b, DCO = 0 | J SV | 4.6 | |
| | | DCORSEL = 010b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 111b, DCO = 511 | | 7.8 | |

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over recommended operating free-air temperature (unless otherwise noted) (see <a>8-6)

| | PARAMETER | TEST CONDITIONS | V _{CC} | TYP | UNIT |
|-------------------------|-----------------------|--|-----------------|------|-------|
| | | DCORSEL = 001b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 000b, DCO = 0 | | 0.96 | |
| f _{DCO, 2MHz} | DCO fraguancy 2 MHz | DCORSEL = 001b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 000b, DCO = 511 | 3 V | 1.6 | MHz |
| | DCO frequency, 2 MHz | DCORSEL = 001b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 111b, DCO = 0 | 3 V | 2.3 | |
| | | DCORSEL = 001b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 111b, DCO = 511 | | 4.0 | |
| | | DCORSEL = 000b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 000b, DCO = 0 | | 0.5 | - MHz |
| force www | DCO frequency, 1 MHz | DCORSEL = 000b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 000b, DCO = 511 | 3 V | 0.85 | |
| f _{DCO} , 1MHz | DCO frequency, 1 Minz | DCORSEL = 000b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 111b, DCO = 0 | 3 V | 1.2 | |
| | | DCORSEL = 000b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 111b, DCO = 511 | | 2.0 | |

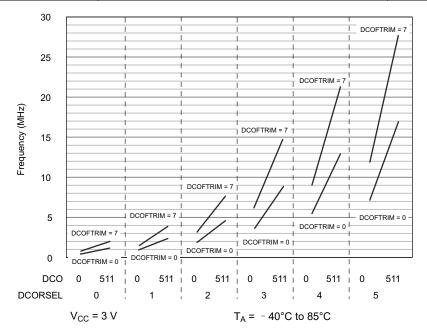


图 8-6. Typical DCO Frequency

节 8.12.3.4 lists the characteristics of the REFO.

8.12.3.4 REFO

over recommended operating free-air temperature (unless otherwise noted)

| | PARAMETER | TEST CONDITIONS | V _{CC} | MIN | TYP | MAX | UNIT |
|--|-------------------------------------|---|-----------------|--------|-------|-------|------|
| I _{REFO} | REFO oscillator current consumption | T _A = 25°C | 3 V | | 15 | | μΑ |
| f | REFO calibrated frequency | Measured at MCLK | 3 V | | 32768 | | Hz |
| f _{REFO} | REFO absolute calibrated tolerance | - 40°C to 85°C | 1.8 V to 3.6 V | - 3.5% | | +3.5% | |
| df _{REFO} /d _T | REFO frequency temperature drift | Measured at MCLK ⁽¹⁾ | 3 V | | 0.01 | | %/°C |
| df _{REFO} / d _{VCC} | REFO frequency supply voltage drift | Measured at MCLK at 25°C ⁽²⁾ | 1.8 V to 3.6 V | | 1 | | %/V |
| f_{DC} | REFO duty cycle | Measured at MCLK | 1.8 V to 3.6 V | 40% | 50% | 60% | |
| t _{START} | REFO start-up time | 40% to 60% duty cycle | | | 50 | | μs |

- (1) Calculated using the box method: (MAX(40°C to 85°C) MIN(40°C to 85°C)) / MIN(40°C to 85°C) / (85°C (40°C))
- (2) Calculated using the box method: (MAX(1.8 V to 3.6 V) MIN(1.8 V to 3.6 V)) / MIN(1.8 V to 3.6 V) / (3.6 V 1.8 V)

8.12.3.5 Internal Very-Low-Power Low-Frequency Oscillator (VLO)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| | PARAMETER | TEST CONDITIONS | V _{cc} | TYP | UNIT |
|-------------------------------------|------------------------------------|---------------------------------|-----------------|-----|------|
| f_{VLO} | VLO frequency | Measured at MCLK | 3 V | 10 | kHz |
| df _{VLO} /d _T | VLO frequency temperature drift | Measured at MCLK ⁽¹⁾ | 3 V | 0.5 | %/°C |
| df _{VLO} /dV _{CC} | VLO frequency supply voltage drift | Measured at MCLK ⁽²⁾ | 1.8 V to 3.6 V | 4 | %/V |
| f _{VLO,DC} | Duty cycle | Measured at MCLK | 3 V | 50% | |

- (1) Calculated using the box method: (MAX(40°C to 85°C) MIN(40°C to 85°C)) / MIN(40°C to 85°C) / (85°C (40°C))
- (2) Calculated using the box method: (MAX(1.8 V to 3.6 V) MIN(1.8 V to 3.6 V)) / MIN(1.8 V to 3.6 V) / (3.6 V 1.8 V)

Note

The VLO clock frequency is reduced by 15% (typical) when the device switches from active mode to LPM3 or LPM4, because the reference changes. This lower frequency is not a violation of the VLO specifications (see † 8.12.3.5).

节 8.12.3.6 lists the characteristics of the MODOSC.

8.12.3.6 Module Oscillator (MODOSC)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| | PARAMETER | TEST CONDITIONS | V _{cc} | MIN | TYP | MAX | UNIT |
|---------------------------------------|---------------------------------------|-----------------|-----------------|-----|-------|-----|------|
| f _{MODOSC} | MODOSC frequency | | 3 V | 3.8 | 4.8 | 5.8 | MHz |
| f _{MODOSC} /dT | MODOSC frequency temperature drift | | 3 V | | 0.102 | | %/℃ |
| f _{MODOSC} /dV _{CC} | MODOSC frequency supply voltage drift | | 1.8 V to 3.6 V | | 1.02 | | %/V |
| f _{MODOSC,DC} | Duty cycle | | 3 V | 40% | 50% | 60% | |

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节 8.12.3.5 lists the characteristics of the VLO.

8.12.4 Digital I/Os

节 8.12.4.1 lists the characteristics of the digital inputs.

8.12.4.1 Digital Inputs

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| | PARAMETER | TEST CONDITIONS | V _{CC} | MIN | TYP | MAX | UNIT |
|------------------------|--|--|-----------------|------|-----|------|------------|
| V | Desitive going input threshold voltage | | 2 V | 0.90 | | 1.50 | V |
| V _{IT+} | Positive-going input threshold voltage | | 3 V | 1.35 | | 2.25 | V |
| V | Negative going input threshold voltage | | 2 V | 0.50 | | 1.10 | V |
| V _{IT} - | Negative-going input threshold voltage | | 3 V | 0.75 | | 1.65 | V |
| V | Input valtage bysteresis (// //) | | 2 V | 0.3 | | 0.8 | V |
| V _{hys} | Input voltage hysteresis (V _{IT+} - V _{IT-}) | | 3 V | 0.4 | | 1.2 | V |
| R _{Pull} | Pullup or pulldown resistor | For pullup: V _{IN} = V _{SS} For pulldown: V _{IN} = V _{CC} | | 20 | 35 | 50 | k Ω |
| C _{I,dig} | Input capacitance, digital only port pins | V _{IN} = V _{SS} or V _{CC} | | | 3 | | pF |
| C _{I,ana} | Input capacitance, port pins with shared analog functions | V _{IN} = V _{SS} or V _{CC} | | | 5 | | pF |
| I _{lkg(Px.y)} | High-impedance leakage current of GPIO pins | See (1) (2) | 2 V, 3 V | - 20 | | 20 | nA |
| t _(int) | External interrupt timing (external trigger pulse duration to set interrupt flag) ⁽³⁾ | Ports with interrupt capability (see block diagram and terminal function descriptions) | 2 V, 3 V | 50 | | | ns |

- (1) The leakage current is measured with V_{SS} or V_{CC} applied to the corresponding pins, unless otherwise noted.
- (2) The leakage of the digital port pins is measured individually. The port pin is selected for input and the pullup or pulldown resistor is disabled.
- (3) An external signal sets the interrupt flag every time the minimum interrupt pulse duration $t_{(int)}$ is met. It may be set by trigger signals shorter than $t_{(int)}$.

节 8.12.4.2 lists the characteristics of the digital outputs.

8.12.4.2 Digital Outputs

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

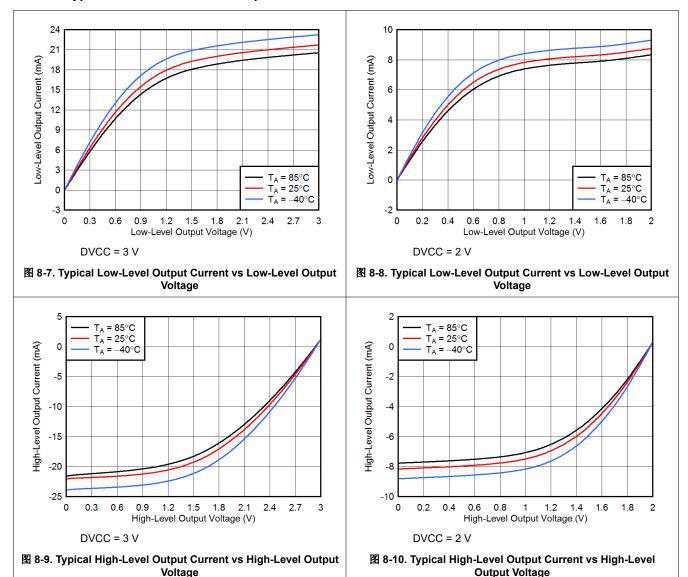
| | PARAMETER | TEST CONDITIONS | V _{cc} | MIN | TYP | MAX | UNIT |
|-----------------------|---|---|-----------------|-----|-----|------|---------|
| V | High-level output voltage | $I_{(OHmax)} = -3 \text{ mA}^{(1)}$ | 2 V | 1.4 | | 2.0 | V |
| V _{OH} | nigri-level output voltage | $I_{(OHmax)} = -5 \text{ mA}^{(1)}$ | 3 V | 2.4 | | 3.0 | " |
| V | Low-level output voltage | $I_{(OLmax)} = 3 \text{ mA}^{(1)}$ | 2 V | 0.0 | | 0.60 | V |
| V _{OL} | Low-level output voltage | $I_{(OHmax)} = 5 \text{ mA}^{(1)}$ | 3 V | 0.0 | | 0.60 | V |
| f | Clock output frequency | C. = 20 pF(2) | 2 V | 16 | | | MHz |
| f _{Port_CLK} | Clock output frequency | C _L = 20 pF ⁽²⁾ | 3 V | 16 | | | IVII IZ |
| + | Port output rise time, digital only port pins | C. = 20 nE | 2 V | | 10 | | ns |
| t _{rise,dig} | Fort output rise time, digital only port pins | e, digital only port pins $C_L = 20 \text{ pF}$ | 3 V | | 7 | | 115 |
| t | Port output fall time, digital only port pins | C ₁ = 20 pF | 2 V | | 10 | | ns |
| t _{fall,dig} | Tort output fail time, digital only port pins | OL - 20 PI | 3 V | | 5 | | 113 |

⁽¹⁾ The maximum total current, I_(OHmax) and I_(OLmax), for all outputs combined should not exceed ±48 mA to hold the maximum voltage drop specified.

⁽²⁾ The port can output frequencies at least up to the specified limit and might support higher frequencies.



8.12.4.3 Typical Characteristics - Outputs at 3 V and 2 V



8.12.5 VREF+ Built-in Reference

节 8.12.5.1 lists the characteristics of the VREF+.

8.12.5.1 VREF+

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| | PARAMETER | TEST CONDITIONS | V _{CC} | MIN | TYP | MAX | UNIT |
|--------------------|---|-------------------------------------|-----------------|------|------|------|-------|
| V_{REF+} | Positive built-in reference voltage | EXTREFEN = 1 with 1-mA load current | 2 V, 3 V | 1.15 | 1.19 | 1.23 | V |
| TC _{REF+} | Temperature coefficient of built-in reference voltage | | | | 30 | | μV/°C |

8.12.6 Timer_A

节 8.12.6.1 lists the characteristics of Timer_A.

8.12.6.1 Timer_A

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| | PARAMETER | TEST CONDITIONS | V _{CC} | MIN | TYP | MAX | UNIT |
|---------------------|-------------------------------|---|-----------------|-----|-----|-----|------|
| f _{TA} | Timer_A input clock frequency | Internal: SMCLK, ACLK External: TACLK Duty cycle = 50% ±10% | 2 V, 3 V | | | 16 | MHz |
| t _{TA,cap} | Timer_A capture timing | All capture inputs, minimum pulse duration required for capture | 2 V, 3 V | 20 | | | ns |

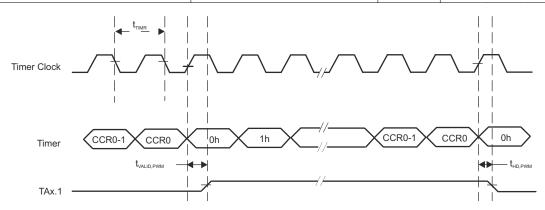


图 8-11. Timer PWM Mode

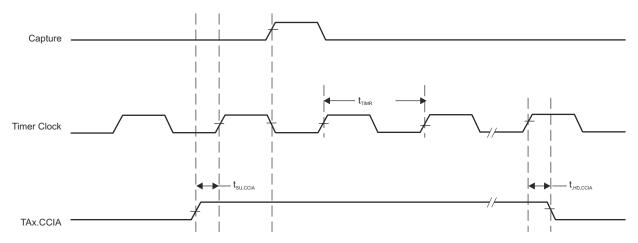


图 8-12. Timer Capture Mode

8.12.7 eUSCI

节 8.12.7.1 lists the supported frequencies of the eUSCI in UART mode.

8.12.7.1 eUSCI (UART Mode) Clock Frequency

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| | PARAMETER | TEST CONDITIONS | V _{cc} | MIN | MAX | UNIT |
|---------------------|---|--|-----------------|-----|-----|------|
| f _{eUSCI} | eUSCI input clock frequency | Internal: SMCLK, MODCLK External: UCLK Duty cycle = 50% ±10% | 2 V, 3 V | | 16 | MHz |
| f _{BITCLK} | BITCLK clock frequency (equals baud rate in Mbaud) | | 2 V, 3 V | | 5 | MHz |

节 8.12.7.2 lists the characteristics of the eUSCI in UART mode.

8.12.7.2 eUSCI (UART Mode)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| | PARAMETER | TEST CONDITIONS | V _{cc} | TYP | UNIT |
|----------------|---------------------------------|-----------------|-----------------|-----|------|
| t _t | | UCGLITx = 0 | | 12 | |
| | LIART receive deglitch time (1) | UCGLITx = 1 | 2 V, 3 V | 40 | no |
| | | UCGLITx = 2 | 2 V, 3 V | 68 | ns |
| | | UCGLITx = 3 | | 110 | |

⁽¹⁾ Pulses on the UART receive input (UCxRX) shorter than the UART receive deglitch time are suppressed. To ensure that pulses are correctly recognized, their duration should exceed the maximum specification of the deglitch time.

节 8.12.7.3 lists the supported frequencies of the eUSCI in SPI master mode.

8.12.7.3 eUSCI (SPI Master Mode) Clock Frequency

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| | PARAMETER | TEST CONDITIONS | MIN | MAX | UNIT |
|--------------------|-------------------------------|--|-----|-----|------|
| f _{eUSCI} | el ISCI innut clock trequency | Internal: SMCLK, MODCLK Duty cycle = 50% ±10% | | 8 | MHz |

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节 8.12.7.4 lists the characteristics of the eUSCI in SPI master mode.

8.12.7.4 eUSCI (SPI Master Mode)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)⁽¹⁾

| PARAMETER | | ETER TEST CONDITIONS | | MIN | MAX | UNIT | |
|-----------------------|--|--------------------------------|-----|-----|-----|--------|--|
| | OTE Is addition. OTE auditor to all adv | UCSTEM = 0, UCMODEx = 01 or 10 | | 1 | 4 | UCxCLK | |
| t _{STE,LEAD} | STE lead time, STE active to clock | UCSTEM = 1, UCMODEx = 01 or 10 | | ! | | cycles | |
| + | OTE to action a fact at all to OTE in action | UCSTEM = 0, UCMODEx = 01 or 10 | | 1 | | UCxCLK | |
| t _{STE,LAG} | STE lag time, last clock to STE inactive | UCSTEM = 1, UCMODEx = 01 or 10 | | ı | | cycles | |
| | SOMI input data setup time | | 2 V | 48 | | ns | |
| t _{SU,MI} | Solvii iriput data setup time | | 3 V | 37 | | 115 | |
| | SOMI input data hold time | | 2 V | 0 | | ns | |
| t _{HD,MI} | | | 3 V | 0 | | 115 | |
| + | SIMO output data valid time ⁽²⁾ | UCLK edge to SIMO valid, | 2 V | | 20 | ns | |
| t _{VALID,MO} | Silvio output data valid time | C _L = 20 pF | 3 V | | 20 | 115 | |
| t _{HD,MO} | SIMO output data hald time(3) | C _L = 20 pF | 2 V | -6 | | no | |
| | SIMO output data hold time ⁽³⁾ | | 3 V | -5 | | ns | |

- $f_{\text{UCxCLK}} = 1/2t_{\text{LO/HI}} \text{ with } t_{\text{LO/HI}} = \max(t_{\text{VALID},\text{MO(eUSCI)}} + t_{\text{SU,SI(Slave)}}, t_{\text{SU,MI(eUSCI)}} + t_{\text{VALID},\text{SO(Slave)}})$ For the slave parameters $t_{\text{SU,SI(Slave)}}$ and $t_{\text{VALID},\text{SO(Slave)}}$, see the SPI parameters of the attached slave. Specifies the time to drive the next valid data to the SIMO output after the output changing UCLK clock edge. See the timing diagrams
- in 图 8-13 and 图 8-14.
- (3) Specifies how long data on the SIMO output is valid after the output changing UCLK clock edge. Negative values indicate that the data on the SIMO output can become invalid before the output changing clock edge observed on UCLK. See the timing diagrams in 🛭 8-13 and 图 8-14.



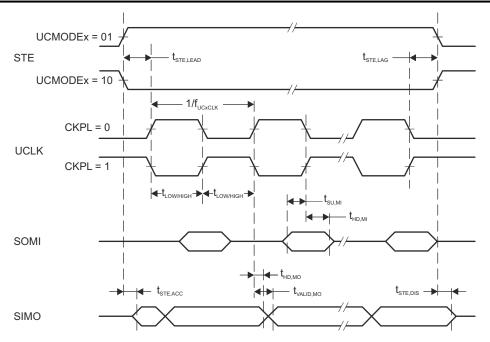


图 8-13. SPI Master Mode, CKPH = 0

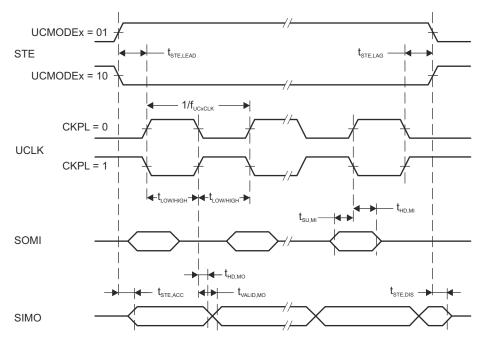


图 8-14. SPI Master Mode, CKPH = 1

节 8.12.7.5 lists the characteristics of the eUSCI in SPI slave mode.

8.12.7.5 eUSCI (SPI Slave Mode)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)(1)

| | PARAMETER | TEST CONDITIONS | V _{cc} | MIN | MAX | UNIT |
|-----------------------|---|--------------------------|-----------------|-----|-----|------|
| t | STE lead time, STE active to clock | | 2 V | 55 | | |
| t _{STE,LEAD} | STE lead tille, STE active to Gock | | 3 V | 45 | | ns |
| + | STE lag time, Last clock to STE inactive | | 2 V | 20 | | ns |
| t _{STE,LAG} | 31E lag time, Last Glock to 31E mactive | | 3 V | 20 | | 115 |
| | STE access time, STE active to SOMI data out | | 2 V | | 65 | no |
| t _{STE,ACC} | STE access time, STE active to SOIVII data out | | 3 V | | 40 | ns |
| | STE disable time, STE inactive to SOMI high impedance | | 2 V | | 40 | ns |
| t _{STE,DIS} | | | 3 V | | 35 | 115 |
| | SIMO input data setup time | | 2 V | 8 | | ns |
| t _{SU,SI} | | | 3 V | 6 | | 115 |
| | CIMO input data hald time | | 2 V | 12 | | 200 |
| t _{HD,SI} | SIMO input data hold time | | 3 V | 12 | | ns |
| | SOMI output data valid time ⁽²⁾ | UCLK edge to SOMI valid, | 2 V | | 68 | ns |
| t _{VALID,SO} | Solvii output data valid time | C _L = 20 pF | 3 V | | 42 | 115 |
| | SOMI output data hald time (3) | C = 20 = E | 2 V | 5 | | no |
| t _{HD,SO} | SOMI output data hold time ⁽³⁾ | C _L = 20 pF | 3 V | 5 | | ns |

 ⁽¹⁾ f_{UCxCLK} = 1/2t_{LO/HI} with t_{LO/HI} ≥ max(t_{VALID,MO(Master)} + t_{SU,SI(eUSCI)}, t_{SU,MI(Master)} + t_{VALID,SO(eUSCI)})
 For the master parameters t_{SU,MI(Master)} and t_{VALID,MO(Master)}, see the SPI parameters of the attached master.
 (2) Specifies the time to drive the next valid data to the SOMI output after the output changing UCLK clock edge. See the timing diagrams

in 图 8-15 and 图 8-16.

⁽³⁾ Specifies how long data on the SOMI output is valid after the output changing UCLK clock edge. See the timing diagrams in 🛭 8-15 and 图 8-16.



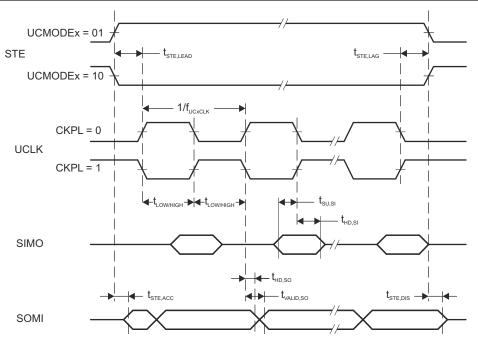


图 8-15. SPI Slave Mode, CKPH = 0

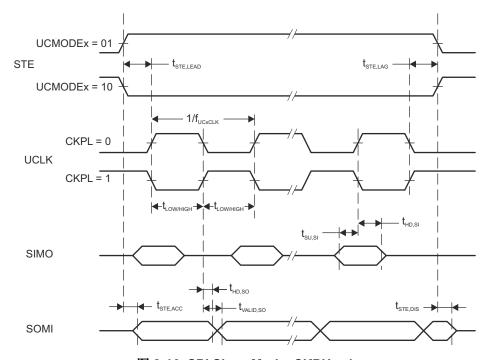


图 8-16. SPI Slave Mode, CKPH = 1

 $\frac{1}{2}$ 8.12.7.6 lists the characteristics of the eUSCI in I²C mode.

8.12.7.6 eUSCI (I²C Mode)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see 🛭 8-17)

| | PARAMETER | TEST CONDITIONS | V _{cc} | MIN | TYP | MAX | UNIT | |
|----------------------|--|--|-----------------|------|-----|-----|------|--|
| f _{eUSCI} | eUSCI input clock frequency | Internal: SMCLK, MODCLK External: UCLK Duty cycle = 50% ±10% | | | | 16 | MHz | |
| f _{SCL} | SCL clock frequency | | 2 V, 3 V | 0 | | 400 | kHz | |
| + | Hold time (repeated) START | f _{SCL} = 100 kHz | 2 V, 3 V | 4.0 | | | | |
| t _{HD,STA} | noid time (repeated) START | f _{SCL} > 100 kHz | 2 V, 3 V | 0.6 | | | μs | |
| + | Setup time for a repeated START | f _{SCL} = 100 kHz | 2 V, 3 V | 4.7 | | | | |
| t _{SU,STA} | Setup time for a repeated START | f _{SCL} > 100 kHz | 2 V, 3 V | 0.6 | | | μs | |
| t _{HD,DAT} | Data hold time | | 2 V, 3 V | 0 | | | ns | |
| t _{SU,DAT} | Data setup time | | 2 V, 3 V | 250 | | | ns | |
| | Setup time for STOP | f _{SCL} = 100 kHz | 2 V, 3 V | 4.0 | | | | |
| t _{SU,STO} | Setup time for STOP | f _{SCL} > 100 kHz | 2 V, 3 V | 0.6 | | | μs | |
| | | UCGLITx = 0 | | 50 | | 600 | ns | |
| • | Pulse duration of spikes suppressed by | UCGLITx = 1 | 2 1/ 2 1/ | 25 | | 300 | | |
| t _{SP} | input filter | UCGLITx = 2 | 2 V, 3 V | 12.5 | | 150 | | |
| | | UCGLITx = 3 | | 6.3 | | 75 | | |
| | Clock low time-out | UCCLTOx = 1 | | | 27 | | | |
| t _{TIMEOUT} | | UCCLTOx = 2 | 2 V, 3 V | | 30 | | ms | |
| | | UCCLTOx = 3 | | | 33 | | | |

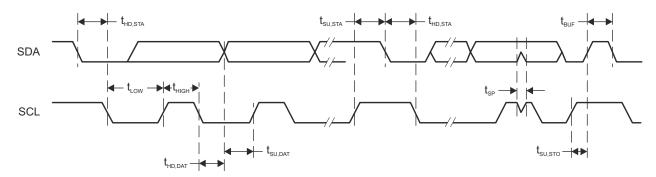


图 8-17. I²C Mode Timing

8.12.8 ADC

节 8.12.8.1 lists the characteristics of the ADC power supply and input range conditions.

8.12.8.1 ADC, Power Supply and Input Range Conditions

over operating free-air temperature range (unless otherwise noted)

| | PARAMETER | TEST CONDITIONS | V _{CC} | MIN | TYP | MAX | UNIT |
|-------------------|---|--|-----------------|-----|-----|---------|------|
| DV _{CC} | ADC supply voltage | | | 2.0 | | 3.6 | V |
| V _(Ax) | Analog input voltage range | All ADC pins | | 0 | | DV_CC | V |
| | Operating supply current into | f _{ADCCLK} = 5 MHz, ADCON = 1, | 2 V | | 185 | | |
| I _{ADC} | DVCC terminal, reference current not included, repeat- single-channel mode | REFON = 0, SHT0 = 0, SHT1 = 0, ADCDIV = 0, ADCCONSEQx = 10b | 3 V | | 207 | | μА |
| Cı | Input capacitance | Only one terminal Ax can be selected at one time from the pad to the ADC capacitor array, including wiring and pad | 2.2 V | | 2.5 | 3.5 | pF |
| R _I | Input MUX ON resistance | DV_{CC} = 2 V, 0 V \leq V _{Ax} \leq DV_{CC} | | | | 36 | kΩ |

节 8.12.8.2 lists the ADC 10-bit timing parameters.

8.12.8.2 ADC, 10-Bit Timing Parameters

over operating free-air temperature range (unless otherwise noted)

| | PARAMETER | TEST CONDITIONS | V _{cc} | MIN | TYP | MAX | UNIT |
|---------------------|----------------------------------|---|-----------------|------|---------------------------------|------|------|
| f _{ADCCLK} | | For specified performance of ADC linearity parameters | 2 V to 3.6 V | 0.45 | 5 | 5.5 | MHz |
| f _{ADCOSC} | Internal ADC oscillator (MODOSC) | ADCDIV = 0, f _{ADCCLK} = f _{ADCOSC} | 2 V to 3.6 V | 3.8 | 4.8 | 5.8 | MHz |
| tconvert | Conversion time | REFON = 0, Internal oscillator, 10 ADCCLK cycles, 10-bit mode, f _{ADCOSC} = 4.5 MHz to 5.5 MHz | 2 V to 3.6 V | 2.18 | | 2.67 | μs |
| | | External f_{ADCCLK} from ACLK, MCLK, or SMCLK, ADCSSEL $\neq 0$ | 2 V to 3.6 V | | 12 × 1 / f _{ADCCLK} | | |
| t _{ADCON} | Turnon settling time of the ADC | The error in a conversion started after t _{ADCON} is less than ±0.5 LSB. Reference and input signal are already settled. | | | | 100 | ns |
| t _{Sample} | Sampling time | R_S = 1000 $Ω$, R_I = 36000 $Ω$, C_I = 3.5 pF. Approximately 8 Tau (t) are required for an error of less than ±0.5 LSB. ⁽¹⁾ | 3 V | 2.0 | | | μs |

(1) $t_{Sample} = In(2^{n+1}) \times \tau$, where n = ADC resolution, $\tau = (R_I + R_S) \times C_I$

节 8.12.8.3 lists the ADC 10-bit linearity parameters.

8.12.8.3 ADC, 10-Bit Linearity Parameters

over operating free-air temperature range (unless otherwise noted)

| | PARAMETER | TEST CONDITIONS | V _{cc} | MIN | TYP | MAX | UNIT |
|------------------------------|---|--|-----------------|--------|------|------|------|
| Eı | Integral linearity error (10-bit mode) | Veref+ reference | 2.4 V to 3.6 V | - 2 | | 2 | LSB |
| - | Integral linearity error (8-bit mode) | | 2.0 V to 3.6 V | - 2 | | 2 | LOD |
| _ | Differential linearity error (10-bit mode) | Veref+ reference | 2.4 V to 3.6 V | - 1 | | 1 | LSB |
| E _D | Differential linearity error (8-bit mode) | - verei+ reierence | 2.0 V to 3.6 V | - 1 | | 1 | LSB |
| _ | Offset error (10-bit mode) | Vereft reference | 2.4 V to 3.6 V | - 6.5 | , | 6.5 | mV |
| Eo | Offset error (8-bit mode) | Veref+ reference | 2.0 V to 3.6 V | - 6.5 | | 6.5 | mv |
| | Cain aman (40 hit mada) | Veref+ as reference | 241/4-261/ | - 2.0 | | 2.0 | LSB |
| _ | Gain error (10-bit mode) | Internal 1.5-V reference | 2.4 V to 3.6 V | - 3.0% | , | 3.0% | |
| E _G | Gain error (8-bit mode) | Veref+ as reference | 2.0 V to 3.6 V | - 2.0 | | 2.0 | LSB |
| | | Internal 1.5-V reference | | - 3.0% | | 3.0% | |
| | Total unadjusted error (10-bit mode) | Veref+ as reference | 2.4 V to 3.6 V | - 2.0 | | 2.0 | LSB |
| _ | | Internal 1.5-V reference | | - 3.0% | | 3.0% | |
| E _T | Total unadjusted error (8-bit mode) | Veref+ as reference | 2.0 V to 3.6 V | - 2.0 | | 2.0 | LSB |
| | | Internal 1.5-V reference | | - 3.0% | | 3.0% | |
| V _{SENSOR} | See (1) | ADCON = 1, INCH = 0Ch, $T_A = 0^{\circ}C$ | 3 V | | 913 | | mV |
| TC _{SENSOR} | See ⁽²⁾ | ADCON = 1, INCH = 0Ch | 3 V | | 3.35 | | mV/℃ |
| t _{SENSOR} (sample) | Sample time required if channel 12 is selected ⁽³⁾ | ADCON = 1, INCH = 0Ch, Error of conversion result ≤1 LSB, AM and all LPMs above LPM3 | 3 V | 30 | | | 110 |
| | | ADCON = 1, INCH = 0Ch, Error of conversion result ≤1 LSB, LPM3 | 3 V | 100 | | | μs |

⁽¹⁾ The temperature sensor offset can vary significantly. TI recommends a single-point calibration to minimize the offset error of the built-in temperature sensor.

⁽²⁾ The device descriptor structure contains calibration values for 30°C and 85°C for each available reference voltage level. The sensor voltage can be computed as V_{SENSOR} × (Temperature, °C) + V_{SENSOR}, where TC_{SENSOR} and V_{SENSOR} can be computed from the calibration values for higher accuracy.

⁽³⁾ The typical equivalent impedance of the sensor is 700 k Ω. The sample time required includes the sensor on time, t_{SENSOR(on)}.



8.12.9 FRAM

节 8.12.9.1 lists the characteristics of the FRAM.

8.12.9.1 FRAM

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| | | <u> </u> | · . | | | |
|------------------------|----------------------------|-----------------------|------------------|--|-----|--------|
| | PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
| | Read and write endurance | | 10 ¹⁵ | | | cycles |
| t _{Retention} | | T _J = 25°C | 100 | | | |
| | | T _J = 70°C | 40 | | | years |
| | | T _J = 85°C | 10 | | | |
| I _{WRITE} | Current to write into FRAM | | | I _{READ} (1) | | nA |
| I _{ERASE} | Erase current | | | N/A ⁽²⁾ | | nA |
| t _{WRITE} | Write time | | | t _{READ} (3) | | ns |
| t _{READ} | Read time | NWAITSx = 0 | | 1 / f _{SYSTEM} (4) | | ns |
| | | NWAITSx = 1 | | 2 / f _{SYSTEM} ⁽⁴⁾ | | 115 |

⁽¹⁾ Writing to FRAM does not require a setup sequence or additional power when compared to reading from FRAM. The FRAM read current I_{READ} is included in the active mode current consumption parameter I_{AM,FRAM}.

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⁽²⁾ FRAM does not require a special erase sequence.

⁽³⁾ Writing into FRAM is as fast as reading.

⁽⁴⁾ The maximum read (and write) speed is specified by f_{SYSTEM} using the appropriate wait state settings (NWAITSx).

8.12.10 Debug and Emulation

节 8.12.10.1 lists the characteristics of the 2-wire SBW interface.

8.12.10.1 JTAG, Spy-Bi-Wire Interface

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see 🛚 8-18)

| | PARAMETER | V _{cc} | MIN | TYP | MAX | UNIT |
|-----------------------------|---|-----------------|-------|-----|-----|------|
| f _{SBW} | Spy-Bi-Wire input frequency | 2 V, 3 V | 0 | | 8 | MHz |
| t _{SBW,Low} | Spy-Bi-Wire low clock pulse duration | 2 V, 3 V | 0.028 | | 15 | μs |
| t _{SU, SBWTDIO} | SBWTDIO setup time (before falling edge of SBWTCK in TMS and TDI slot, Spy-Bi-Wire) | 2 V, 3 V | 4 | | | ns |
| t _{HD, SBWTDIO} | SBWTDIO hold time (after rising edge of SBWTCK in TMS and TDI slot, Spy-Bi-Wire) | 2 V, 3 V | 19 | | | ns |
| t _{Valid, SBWTDIO} | SBWTDIO data valid time (after falling edge of SBWTCK in TDO slot, Spy-Bi-Wire) | 2 V, 3 V | | | 31 | ns |
| t _{SBW, En} | Spy-Bi-Wire enable time (TEST high to acceptance of first clock edge) (1) | 2 V, 3 V | | | 110 | μs |
| t _{SBW,Ret} | Spy-Bi-Wire return to normal operation time ⁽²⁾ | 2 V, 3 V | 15 | | 100 | μs |
| R _{internal} | Internal pulldown resistance on TEST | 2 V, 3 V | 20 | 35 | 50 | kΩ |

- (1) Tools that access the Spy-Bi-Wire interface must wait for the t_{SBW,En} time after pulling the TEST/SBWTCK pin high before applying the first SBWTCK clock edge.
- (2) Maximum t_{SBW,Ret} time after pulling or releasing the TEST/SBWTCK pin low until the Spy-Bi-Wire pins revert from their Spy-Bi-Wire function to their application function. This time applies only if the Spy-Bi-Wire mode is selected.

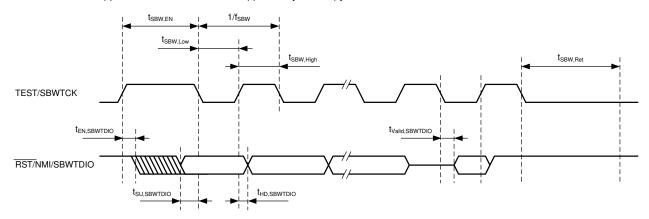


图 8-18. JTAG Spy-Bi-Wire Timing

节 8.12.10.2 lists the characteristics of the 4-wire JTAG interface.

8.12.10.2 JTAG, 4-Wire Interface

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see 🛭 8-19)

| PARAMETER | V _{cc} | MIN | TYP | MAX | UNIT |
|---|---|---|--|--|--|
| TCK input frequency ⁽¹⁾ | 2 V, 3 V | 0 | | 10 | MHz |
| TCK low clock pulse duration | 2 V, 3 V | 15 | | | ns |
| TCK high clock pulse duration | 2 V, 3 V | 15 | | | ns |
| TMS setup time (before rising edge of TCK) | 2 V, 3 V | 11 | | | ns |
| TMS hold time (after rising edge of TCK) | 2 V, 3 V | 3 | | | ns |
| TDI setup time (before rising edge of TCK) | 2 V, 3 V | 13 | | | ns |
| TDI hold time (after rising edge of TCK) | 2 V, 3 V | 5 | | | ns |
| TDO high impedance to valid output time (after falling edge of TCK) | 2 V, 3 V | | | 26 | ns |
| TDO to new valid output time (after falling edge of TCK) | 2 V, 3 V | | | 26 | ns |
| TDO valid to high-impedance output time (after falling edge of TCK) | 2 V, 3 V | | | 26 | ns |
| Spy-Bi-Wire return to normal operation time | | 15 | | 100 | μs |
| Internal pulldown resistance on TEST | 2 V, 3 V | 20 | 35 | 50 | kΩ |
| | TCK input frequency ⁽¹⁾ TCK low clock pulse duration TCK high clock pulse duration TMS setup time (before rising edge of TCK) TMS hold time (after rising edge of TCK) TDI setup time (before rising edge of TCK) TDI hold time (after rising edge of TCK) TDO high impedance to valid output time (after falling edge of TCK) TDO to new valid output time (after falling edge of TCK) TDO valid to high-impedance output time (after falling edge of TCK) Spy-Bi-Wire return to normal operation time | TCK input frequency ⁽¹⁾ 2 V, 3 V TCK low clock pulse duration 2 V, 3 V TCK high clock pulse duration 2 V, 3 V TMS setup time (before rising edge of TCK) 2 V, 3 V TMS hold time (after rising edge of TCK) 2 V, 3 V TDI setup time (before rising edge of TCK) 2 V, 3 V TDI hold time (after rising edge of TCK) 2 V, 3 V TDI hold time (after rising edge of TCK) 2 V, 3 V TDO high impedance to valid output time (after falling edge of TCK) 2 V, 3 V TDO to new valid output time (after falling edge of TCK) 2 V, 3 V TDO valid to high-impedance output time (after falling edge of TCK) 2 V, 3 V Spy-Bi-Wire return to normal operation time | TCK input frequency ⁽¹⁾ 2 V, 3 V 0 TCK low clock pulse duration 2 V, 3 V 15 TCK high clock pulse duration 2 V, 3 V 15 TMS setup time (before rising edge of TCK) 2 V, 3 V 11 TMS hold time (after rising edge of TCK) 2 V, 3 V 3 TDI setup time (before rising edge of TCK) 2 V, 3 V 13 TDI hold time (after rising edge of TCK) 2 V, 3 V 5 TDO high impedance to valid output time (after falling edge of TCK) 2 V, 3 V TDO to new valid output time (after falling edge of TCK) 2 V, 3 V TDO valid to high-impedance output time (after falling edge of TCK) Spy-Bi-Wire return to normal operation time | TCK input frequency ⁽¹⁾ 2 V, 3 V 0 TCK low clock pulse duration 2 V, 3 V 15 TCK high clock pulse duration 2 V, 3 V 15 TMS setup time (before rising edge of TCK) 2 V, 3 V 11 TMS hold time (after rising edge of TCK) 2 V, 3 V 3 TDI setup time (before rising edge of TCK) 2 V, 3 V 13 TDI hold time (after rising edge of TCK) 2 V, 3 V 5 TDO high impedance to valid output time (after falling edge of TCK) 2 V, 3 V TDO to new valid output time (after falling edge of TCK) 2 V, 3 V TDO valid to high-impedance output time (after falling edge of TCK) Spy-Bi-Wire return to normal operation time | TCK input frequency ⁽¹⁾ 2 V, 3 V 0 10 TCK low clock pulse duration 2 V, 3 V 15 TCK high clock pulse duration 2 V, 3 V 15 TMS setup time (before rising edge of TCK) 2 V, 3 V 11 TMS hold time (after rising edge of TCK) 2 V, 3 V 3 TDI setup time (before rising edge of TCK) 2 V, 3 V 13 TDI hold time (after rising edge of TCK) 2 V, 3 V 5 TDO high impedance to valid output time (after falling edge of TCK) 2 V, 3 V 26 TDO valid to high-impedance output time (after falling edge of TCK) 2 V, 3 V 26 Spy-Bi-Wire return to normal operation time |

(1) f_{TCK} may be restricted to meet the timing requirements of the module selected.

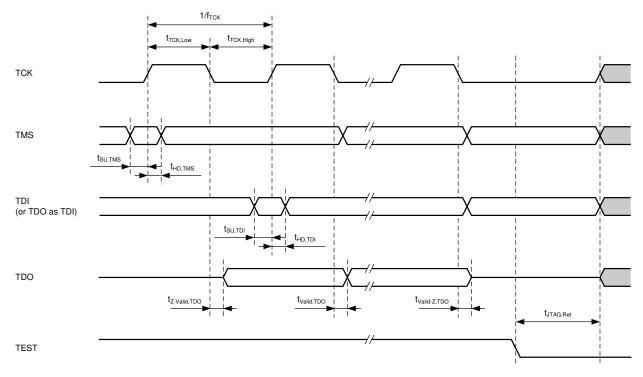


图 8-19. JTAG 4-Wire Timing

9 Detailed Description

9.1 Overview

The MSP430FR2422 is an ultra-low-power MCU. The architecture, combined with extensive low-power modes, is optimized to achieve extended battery life in, for example, portable measurement applications. The MCU features two 16-bit timers, two eUSCIs that support UART, SPI, and I²C, a hardware multiplier, an RTC module, and a high-performance 10-bit ADC.

9.2 CPU

The MSP430 CPU has a 16-bit RISC architecture that is highly transparent to the application. All operations, other than program-flow instructions, are performed as register operations in conjunction with seven addressing modes for source operand and four addressing modes for destination operand.

The CPU is integrated with 16 registers that provide reduced instruction execution time. The register-to-register operation execution time is one cycle of the CPU clock.

Four of the registers, R0 to R3, are dedicated as program counter (PC), stack pointer (SP), status register (SR), and constant generator (CG), respectively. The remaining registers are general-purpose registers.

Peripherals are connected to the CPU using data, address, and control buses. Peripherals can be handled with all instructions.

9.3 Operating Modes

The MSP430 has one active mode and several software-selectable low-power modes of operation (see $\frac{1}{8}$ 9-1). An interrupt event can wake the MCU from low-power mode LPM0, LPM3 or LPM4, service the request, and restore the MCU back to the low-power mode on return from the interrupt program. Low-power modes LPM3.5 and LPM4.5 disable the core supply to minimize power consumption.

Note

XT1CLK and VLOCLK can be active during LPM4 mode if requested by low-frequency peripherals, such as RTC and WDT.



表 9-1. Operating Modes

| | | | LDMO | I DMA | I DM4 | I DMO E | LDM4.5 |
|----------------------|--------------------------------------|-----------------------------|-----------------|--|------------------------|---|----------------------|
| | | AM | LPM0 | LPM3 | LPM4 | LPM3.5 | LPM4.5 |
| | MODE | ACTIVE MODE (FRAM ON) | CPU OFF | STANDBY | OFF | ONLY RTC | SHUTDOWN |
| Maximum sys | tem clock | 16 MHz | 16 MHz | 40 kHz | 0 | 40 kHz | 0 |
| Power consun | nption at 25°C, 3 V | 126 μA/MHz | 40 μA/MHz | 1.2 µA with RTC counter only in LFXT | 0.49 μA without SVS | 0.73 μA with RTC counter only in LFXT | 16 nA without SVS |
| Wake-up time | | N/A | Instant | 10 µs | 10 µs | 350 µs | 350 µs |
| Wake-up ever | nts | N/A | All | All | I/O | RTC I/O | I/O |
| | Regulator | Full Regulation | Full Regulation | Partial Power Down | Partial Power Down | Partial Power Down | Power Down |
| Power | SVS | On | On | Optional | Optional | Optional | Optional |
| | Brownout | On | On | On | On | On | On |
| | MCLK | Active | Off | Off | Off | Off | Off |
| | SMCLK | Optional | Optional | Off | Off | Off | Off |
| | FLL | Optional | Optional | Off | Off | Off | Off |
| | DCO | Optional | Optional | Off | Off | Off | Off |
| Clock ⁽²⁾ | MODCLK | Optional | Optional | Off | Off | Off | Off |
| | REFO | Optional | Optional | Optional | Off | Off | Off |
| | ACLK | Optional | Optional | Optional | Off | Off | Off |
| | XT1CLK | Optional | Optional | Optional | Off | Optional | Off |
| | VLOCLK | Optional | Optional | Optional | Off | Optional | Off |
| | CPU | On | Off | Off | Off | Off | Off |
| Core | FRAM | On | On | Off | Off | Off | Off |
| Core | RAM | On | On | On | On | Off | Off |
| | Backup memory ⁽¹⁾ | On | On | On | On | On | Off |
| | Timer0_A3 | Optional | Optional | Optional | Off | Off | Off |
| | Timer1_A3 | Optional | Optional | Optional | Off | Off | Off |
| | WDT | Optional | Optional | Optional | Off | Off | Off |
| Peripherals | eUSCI_A0 | Optional | Optional | Optional | Off | Off | Off |
| | eUSCI_B0 | Optional | Optional | Optional | Off | Off | Off |
| | CRC | Optional | Optional | Off | Off | Off | Off |
| | ADC | Optional | Optional | Optional | Off | Off | Off |
| | RTC | Optional | Optional | Optional | Off | Optional | Off |
| I/O | General-purpose digital input/output | On | Optional | State Held | State Held | State Held | State Held |

Backup memory contains 32 bytes of register space in peripheral memory. See $\frac{1}{8}$ 9-20 and $\frac{1}{8}$ 9-35 for its memory allocation. The status shown for LPM4 applies to internal clocks only. (1)

9.4 Interrupt Vector Addresses

The interrupt vectors and the power-up start address are in the address range 0FFFFh to 0FF80h (see 表 9-2). The vector contains the 16-bit address of the appropriate interrupt-handler instruction sequence.

表 9-2. Interrupt Sources, Flags, and Vectors

| INTERRUPT SOURCE | INTERRUPT FLAG | SYSTEM INTERRUPT | WORD ADDRESS | PRIORITY |
|--|--|---------------------|-----------------|-------------|
| System Reset Power up, Brownout, Supply supervisor External reset RST Watchdog time-out, Key violation FRAM uncorrectable bit error detection Software POR, BOR FLL unlock error | SVSHIFG PMMRSTIFG WDTIFG PMMPORIFG, PMMBORIFG SYSRSTIV FLLUNLOCKIFG | Reset | FFFEh | 63, Highest |
| System NMI Vacant memory access JTAG mailbox FRAM access time error FRAM bit error detection | VMAIFG JMBINIFG, JMBOUTIFG CBDIFG, UBDIFG | Nonmaskable | FFFCh | 62 |
| User NMI External NMI Oscillator fault | NMIIFG OFIFG | Nonmaskable | FFFAh | 61 |
| Timer0_A3 | TA0CCR0 CCIFG0 | Maskable | FFF8h | 60 |
| Timer0_A3 | Timer0_A3 TA0CCR1 CCIFG1, TA0CCR2 CCIFG2, TA0IFG (TA0IV) | | FFF6h | 59 |
| Timer1_A3 | TA1CCR0 CCIFG0 | Maskable | FFF4h | 58 |
| Timer1_A3 | TA1CCR1 CCIFG1, TA1CCR2 CCIFG2, TA1IFG (TA1IV) | Maskable | FFF2h | 57 |
| RTC | RTCIFG | Maskable | FFF0h | 56 |
| Watchdog timer interval mode | WDTIFG | Maskable | FFEEh | 55 |
| eUSCI_A0 receive or transmit | UCTXCPTIFG, UCSTTIFG, UCRXIFG, UCTXIFG (UART mode) UCRXIFG, UCTXIFG (SPI mode) (UCA0IV) | Maskable | FFECh | 54 |
| eUSCI_B0 receive or transmit | UCBORXIFG, UCBOTXIFG (SPI mode) UCALIFG, UCNACKIFG, UCSTTIFG, UCSTPIFG, UCRXIFGO, UCTXIFGO, UCRXIFG1, UCTXIFG1, UCRXIFG2, UCTXIFG2, UCRXIFG3, UCTXIFG3, UCCNTIFG, UCBIT9IFG (I ² C mode) (UCB0IV) | | FFEAh | 53 |
| ADC | ADCIFG0, ADCINIFG, ADCLOIFG, ADCHIIFG, ADCTOVIFG, ADCOVIFG Maskable FFE8h (ADCIV) | | 52 | |
| P1 | P1IFG.0 to P1IFG.7 (P1IV) | Maskable | FFE6h | 51 |
| P2 | P2IFG.0 to P2IFG.6 (P2IV) | Maskable | FFE4h | 50 |
| Reserved | Reserved | Maskable | FFE0h - FF88h | |

表 9-3. Signatures

| <u>_</u> | | | | | | |
|-----------------|--------------|--|--|--|--|--|
| SIGNATURE | WORD ADDRESS | | | | | |
| BSL Signature2 | 0FF86h | | | | | |
| BSL Signature1 | 0FF84h | | | | | |
| JTAG Signature2 | 0FF82h | | | | | |
| JTAG Signature1 | 0FF80h | | | | | |

9.5 Bootloader (BSL)

The BSL lets users program the FRAM or RAM using either the UART serial interface or the I^2C interface. Access to the MCU memory through the BSL is protected by an user-defined password. Use of the BSL requires four pins (see $\frac{1}{8}$ 9-4 and $\frac{1}{8}$ 9-5). The BSL entry requires a specific entry sequence on the $\frac{1}{8}$ NMI/SBWTDIO and TEST/SBWTCK pins. This device can support the blank device detection automatically to invoke the BSL with bypass this special entry sequence for saving time and on board programmable. For the complete description of the feature of the BSL, see the MSP430 FRAM Device Bootloader (BSL) User's Guide.

表 9-4. UART BSL Pin Requirements and Functions

| BSL FUNCTION |
|-----------------------|
| Entry sequence signal |
| Entry sequence signal |
| Data transmit |
| Data receive |
| Power supply |
| Ground supply |
| |

表 9-5. I²C BSL Pin Requirements and Functions

| DEVICE SIGNAL | BSL FUNCTION |
|-----------------|---------------------------|
| RST/NMI/SBWTDIO | Entry sequence signal |
| TEST/SBWTCK | Entry sequence signal |
| P1.2 | Data transmit and receive |
| P1.3 | Clock |
| DVCC | Power supply |
| DVSS | Ground supply |

9.6 JTAG Standard Interface

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The MSP low-power microcontrollers support the standard JTAG interface, which requires four signals for sending and receiving data. The JTAG signals are shared with general-purpose I/O. The TEST/SBWTCK pin enables the JTAG signals. In addition to these signals, the RST/NMI/SBWTDIO is required to interface with MSP430 development tools and device programmers. 表 9-6 lists the JTAG pin requirements. For further details on interfacing to development tools and device programmers, see the MSP430 Hardware Tools User's Guide. For details on using the JTAG interface, see MSP430 Programming With the JTAG Interface.

表 9-6. JTAG Pin Requirements and Function

| DEVICE SIGNAL | DIRECTION | JTAG FUNCTION |
|-----------------|--------------------|-----------------------------|
| P1.4//TCK | IN | JTAG clock input |
| P1.5//TMS | IN | JTAG state control |
| P1.6//TDI/TCLK | IN | JTAG data input, TCLK input |
| P1.7//TDO | OUT | JTAG data output |
| TEST/SBWTCK | IN | Enable JTAG pins |
| RST/NMI/SBWTDIO | RST/NMI/SBWTDIO IN | |
| DVCC | DVCC - | |
| DVSS | - | Ground supply |

Product Folder Links: MSP430FR2422

9.7 Spy-Bi-Wire Interface (SBW)

The MSP low-power microcontrollers support the 2-wire SBW interface. SBW can be used to interface with MSP development tools and device programmers. 表 9-7 lists the SBW interface pin requirements. For further details on interfacing to development tools and device programmers, see the *MSP430 Hardware Tools User's Guide*. For details on using the SBW interface, see the *MSP430 Programming With the JTAG Interface*.

| 表 9-7. Spy-Bi-Wii | re Pin Requiren | nents and Functions |
|-------------------|-----------------|---------------------|
| #0E 0101141 | DIDECTION | ODW FUNCTI |

| DEVICE SIGNAL | DIRECTION | SBW FUNCTION |
|-----------------|-----------|-----------------------------------|
| TEST/SBWTCK | IN | Spy-Bi-Wire clock input |
| RST/NMI/SBWTDIO | IN, OUT | Spy-Bi-Wire data input and output |
| DVCC | - | Power supply |
| DVSS | - | Ground supply |

9.8 FRAM

The FRAM can be programmed using the JTAG port, SBW, the BSL, or in-system by the CPU. Features of the FRAM include:

- Byte and word access capability
- · Programmable wait state generation
- Error correction coding (ECC)

9.9 Memory Protection

The device features memory protection for user access authority and write protection, including options to:

- Secure the whole memory map to prevent unauthorized access from JTAG port or BSL, by writing JTAG and BSL signatures using the JTAG port, SBW, the BSL, or in-system by the CPU.
- Enable write protection to prevent unwanted write operation to FRAM contents by setting the control bits in the System Configuration 0 register. For detailed information, see the SYS chapter in the MP430FR4xx and MP430FR2xx Family User's Guide.

9.10 Peripherals

Peripherals are connected to the CPU through data, address, and control buses. All peripherals can be handled by using all instructions in the memory map. For complete module description, see the MP430FR4xx and MP430FR2xx Family User's Guide.

9.10.1 Power-Management Module (PMM)

The PMM includes an integrated voltage regulator that supplies the core voltage to the device. The PMM also includes supply voltage supervisor (SVS) and brownout protection. The brownout reset circuit (BOR) is implemented to provide the proper internal reset signal to the device during power on and power off. The SVS circuitry detects if the supply voltage drops below a user-selectable safe level. SVS circuitry is available on the primary supply.

The device contains two on-chip reference: 1.5 V for internal reference and 1.2 V for external reference.

The 1.5-V reference is internally connected to ADC channel 13. DVCC is internally connected to ADC channel 15. When DVCC is set as the reference voltage for ADC conversion, the DVCC can be easily represent as 方程式 1 by using ADC sampling 1.5-V reference without any external components support.

DVCC =
$$(1023 \times 1.5 \text{ V}) \div 1.5 \text{-V}$$
 reference ADC result (1)

A 1.2-V reference voltage can be buffered, when EXTREFEN = 1 on PMMCTL2 register, and it can be output to P1.1/../A1/VREF+, meanwhile the ADC channel 1 can also be selected to monitor this voltage. For more detailed information, see the MSP430FR4xx and MSP430FR2xx Family User's Guide.

9.10.2 Clock System (CS) and Clock Distribution

The clock system includes a 32-kHz crystal oscillator (XT1), an internal very-low-power low-frequency oscillator (VLO), an integrated 32-kHz RC oscillator (REFO), an integrated internal digitally controlled oscillator (DCO) that may use frequency-locked loop (FLL) locking with internal or external 32-kHz reference clock, and an on-chip asynchronous high-speed clock (MODOSC). The clock system is designed for cost-effective designs with minimal external components. A fail-safe mechanism is included for XT1. The clock system module offers the following clock signals.

- Main Clock (MCLK): The system clock used by the CPU and all relevant peripherals accessed by the bus. All
 clock sources except MODOSC can be selected as the source with a predivider of 1, 2, 4, 8, 16, 32, 64, or
 128.
- Sub-Main Clock (SMCLK): The subsystem clock used by the peripheral modules. SMCLK derives from the MCLK with a predivider of 1, 2, 4, or 8. This means SMCLK is always equal to or less than MCLK.
- Auxiliary Clock (ACLK): This clock is derived from the external XT1 clock or internal REFO clock up to 40 kHz.

All peripherals may have one or several clock sources depending on specific functionality. $\frac{1}{2}$ 9-8 lists the clock distribution used in this device.

| ₹ 5-0. Glock Distribution | | | | | | | | |
|---------------------------|-----------------------------------|-----------------|--------------------|--------------------|------------|--------------|-------------|-------------------|
| | CLOCK SOURCE SELECT BITS | MCLK | SMCLK | ACLK | MODCLK | XT1CLK | VLOCLK | EXTERNAL PIN |
| Frequency Range | | DC to 16 MHz | DC to 16 MHz | DC to 40 kHz | 5 MHz ±10% | DC to 40 kHz | 10 kHz ±50% | - |
| CPU | N/A | Default | - | - | - | - | - | - |
| FRAM | N/A | Default | - | - | - | - | - | - |
| RAM | N/A | Default | - | - | - | - | - | - |
| CRC | N/A | Default | - | - | - | - | - | - |
| I/O | N/A | Default | - | - | - | - | - | - |
| TA0 | TASSEL | - | 10b | 01b | - | - | 11b | 00b (TA0CLK pin) |
| TA1 | TASSEL | - | 10b | 01b | - | - | - | 00b (TA1CLK pin) |
| eUSCI_A0 | UCSSEL | - | 10b or 11b | 01b | - | - | - | 00b (UCA0CLK pin) |
| eUSCI_B0 | UCSSEL | - | 10b or 11b | 01b | - | - | - | 00b (UCB0CLK pin) |
| WDT | WDTSSEL | - | 00b | 01b | - | - | 10b | - |
| ADC | ADCSSEL | - | 10b or 11b | 01b | 00b | - | - | - |
| RTC | RTCSS | - | 01b ⁽¹⁾ | 01b ⁽¹⁾ | - | 10b | 11b | - |

表 9-8. Clock Distribution

(1) Controlled by the RTCCKSEL bit in the SYSCFG2 register

Selected on SYSCFG2

XT1CLK

TAOCLK

TA1CLK

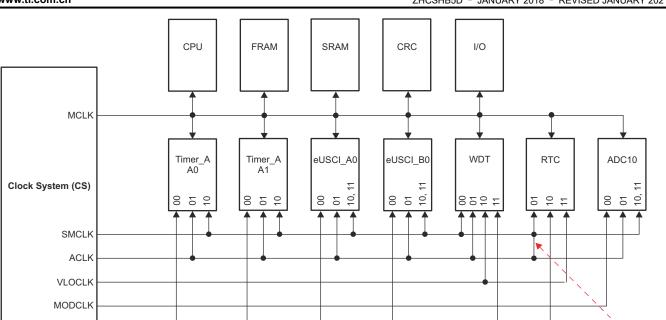


图 9-1. Clock Distribution Block Diagram

UBOCLK

9.10.3 General-Purpose Input/Output Port (I/O)

Up to 15 I/O ports are implemented.

- P1 implements 8 bits, and P2 implements 7 bits.
- All individual I/O bits are independently programmable.
- · Any combination of input, output, and interrupt conditions is possible.
- · Programmable pullup or pulldown on all ports.
- Edge-selectable interrupt and LPMx.5 wake-up input capability are available for P1 and P2.
- Read and write access to port-control registers is supported by all instructions.
- · Ports can be accessed byte-wise or word-wise as a pair.

Note

Configuration of digital I/Os after BOR reset

To prevent any cross currents during start-up of the device, all port pins are high-impedance with Schmitt triggers and module functions disabled. To enable the I/O functions after a BOR reset, the ports must be configured first and then the LOCKLPM5 bit must be cleared. For details, see the Configuration After Reset section in the Digital I/O chapter of the MP430FR4xx and MP430FR2xx Family User's Guide.

9.10.4 Watchdog Timer (WDT)

The primary function of the WDT module is to perform a controlled system restart after a software problem occurs. If the selected time interval expires, a system reset is generated. If the watchdog function is not needed in an application, the module can be configured as an interval timer and can generate interrupts at selected time intervals. $\frac{1}{2}$ 9-9 lists the system clocks that can be used to source the WDT.

表 9-9. WDT Clocks

| WDTSSEL | NORMAL OPERATION (WATCHDOG AND INTERVAL TIMER MODE) |
|---------|---|
| 00 | SMCLK |
| 01 | ACLK |
| 10 | VLOCLK |
| 11 | Reserved |

Product Folder Links: MSP430FR2422

9.10.5 System (SYS) Module

The SYS module handles many of the system functions within the device. These features include power-on reset (POR) and power-up clear (PUC) handling, NMI source selection and management, reset interrupt vector generators, bootloader entry mechanisms, and configuration management (device descriptors). The SYS module also includes a data exchange mechanism through SBW called a JTAG mailbox mail box that can be used in the application. 表 9-10 summarizes the interrupts that are managed by the SYS module.

表 9-10. System Module Interrupt Vector Registers

| INTERRUPT VECTOR REGISTER | ADDRESS | INTERRUPT EVENT | VALUE | PRIORITY |
|------------------------------|------------------------------------|--|-----------------|----------|
| | | No interrupt pending | 00h | |
| | | Brownout (BOR) | 02h | Highest |
| | | RSTIFG RST/NMI (BOR) | 04h | |
| | | PMMSWBOR software BOR (BOR) | 06h | |
| | | LPMx.5 wakeup (BOR) | 08h | |
| | | Security violation (BOR) | 0Ah | |
| | | Reserved | 0Ch | |
| | | SVSHIFG SVSH event (BOR) | 0Eh | |
| | | Reserved | 10h | |
| SYSRSTIV, System Reset | 015Eh | Reserved | 12h | |
| | | PMMSWPOR software POR (POR) | 14h | |
| | | WDTIFG watchdog time-out (PUC) | 16h | |
| | | WDTPW password violation (PUC) | 18h | |
| | | FRCTLPW password violation (PUC) | 1Ah | |
| | | Uncorrectable FRAM bit error detection | 1Ch | |
| | | Peripheral area fetch (PUC) | 1Eh | |
| | PMMPW PMM password violation (PUC) | 20h | | |
| | | FLL unlock (PUC) | 24h | |
| | | Reserved | 22h, 26h to 3Eh | Lowest |
| | | No interrupt pending | 00h | |
| | | SVS low-power reset entry | 02h | Highest |
| | | Uncorrectable FRAM bit error detection | 04h | |
| | | Reserved | 06h | |
| | | Reserved | 08h | |
| | | Reserved | 0Ah | |
| | | Reserved | 0Ch | |
| SYSSNIV, System NMI | 015Ch | Reserved | 0Eh | |
| | | Reserved | 10h | |
| | | VMAIFG vacant memory access | 12h | |
| | | JMBINIFG JTAG mailbox input | 14h | |
| | | JMBOUTIFG JTAG mailbox output | 16h | |
| | | Correctable FRAM bit error detection | 18h | |
| | | Reserved | 1Ah to 1Eh | Lowest |
| | | No interrupt pending | 00h | |
| | - | NMIIFG NMI pin or SVS _H event | 02h | Highest |
| SYSUNIV, User NMI | 015Ah | OFIFG oscillator fault | 04h | |
| | | Reserved | 06h to 1Eh | Lowest |

9.10.6 Cyclic Redundancy Check (CRC)

The 16-bit cyclic redundancy check (CRC) module produces a signature based on a sequence of data values and can be used for data checking purposes. The CRC generation polynomial is compliant with CRC-16-CCITT standard of $x^{16} + x^{12} + x^5 + 1$.

9.10.7 Enhanced Universal Serial Communication Interface (eUSCI A0, eUSCI B0)

The eUSCI modules are used for serial data communications. The eUSCI A module supports either UART or SPI communications. The eUSCI_B module supports either SPI or I²C communications. Additionally, eUSCI_A supports automatic baud-rate detection and IrDA. The eUSCI_A and eUSCI_B are connected either from P1 port or P2 port, it can be selected from the USCIARMP of SYSCFG3 or USCIBRMP bit of SYSCFG2. 表 9-11 lists the pin configurations that are required for each eUSCI mode.

表 9-11. eUSCI Pin Configurations

| | DIN (ICCIADAD - O) | | | | | | |
|----------|--------------------|------------------|------|--|--|--|--|
| | PIN (USCIARMP = 0) | UART | SPI | | | | |
| | P1.4 | TXD | SIMO | | | | |
| | P1.5 | RXD | SOMI | | | | |
| | P1.6 | - | SCLK | | | | |
| eUSCI_A0 | P1.7 | - | STE | | | | |
| 603CI_A0 | PIN (USCIARMP = 1) | UART | SPI | | | | |
| | P2.0 | TXD | SIMO | | | | |
| | P2.1 | RXD | SOMI | | | | |
| | P1.6 | - | SCLK | | | | |
| | P1.7 | - | STE | | | | |
| | PIN (USCIBRMP = 0) | I ² C | SPI | | | | |
| | P1.0 | - | STE | | | | |
| | P1.1 | - | SCLK | | | | |
| | P1.2 | SDA | SIMO | | | | |
| eUSCI_B0 | P1.3 | SCL | SOMI | | | | |
| 60301_00 | PIN (USCIBRMP = 1) | I ² C | SPI | | | | |
| | P2.3 | - | STE | | | | |
| | P2.4 | - | SCLK | | | | |
| | P2.5 | SDA | SIMO | | | | |
| | | SCL | SOMI | | | | |

Product Folder Links: MSP430FR2422

9.10.8 Timers (Timer0_A3, Timer1_A3)

The Timer0_A3 and Timer1_A3 modules are 16-bit timers and counters with three capture/compare registers each. Each timer supports multiple captures or compares, PWM outputs, and interval timing (see § 9-2). Each timer has extensive interrupt capabilities. Interrupts may be generated from the counter on overflow conditions and from each of the capture/compare registers. The CCR0 registers on both Timer0_A3 and Timer1_A3 are not externally connected and can only be used for hardware period timing and interrupt generation. In Up mode, they can be used to set the overflow value of the counter.

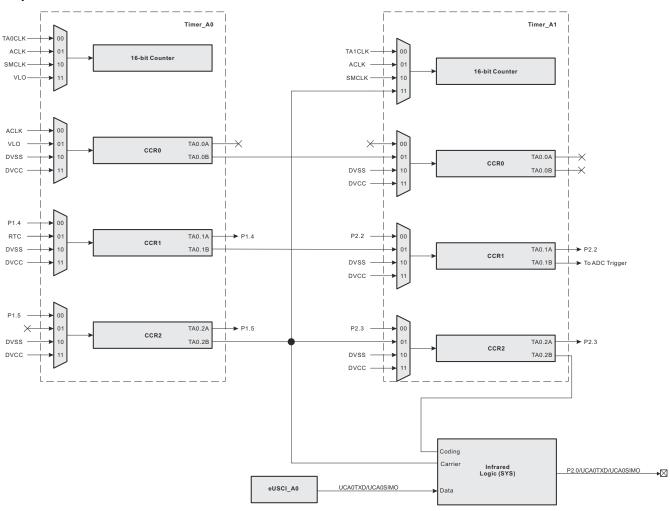


图 9-2. Timer0_A3 and Timer1_A3 Signal Connections

The interconnection of Timer0_A3 and Timer1_A3 can be used to modulate the eUSCI_A pin of UCA0TXD/UCA0SIMO in either ASK or FSK mode, with which a user can easily acquire a modulated infrared command for directly driving an external IR diode. The IR functions are fully controlled by SYS configuration registers 1 including IREN (enable), IRPSEL (polarity select), IRMSEL (mode select), IRDSSEL (data select), and IRDATA (data) bits. For more information, see the SYS chapter in the MP430FR4xx and MP430FR2xx Family User's Guide.

9.10.9 Hardware Multiplier (MPY)

The multiplication operation is supported by a dedicated peripheral module. The module performs operations with 32-, 24-, 16-, and 8-bit operands. The MPY module supports signed multiplication, unsigned multiplication, signed multiply-and-accumulate, and unsigned multiply-and-accumulate operations.

9.10.10 Backup Memory (BAKMEM)

The BAKMEM supports data retention during LPM3.5. This device provides up to 32 bytes that are retained during LPM3.5.

9.10.11 Real-Time Clock (RTC)

The RTC is a 16-bit modulo counter that is functional in AM, LPM0, LPM3, and LPM3.5. This module can periodically wake up the CPU from LPM0, LPM3, or LPM3.5 based on timing from a low-power clock source such as the XT1 and VLO clocks. RTC also can be sourced from ACLK controlled by RTCCLK in SYSCFG2. In AM, RTC can be driven by SMCLK to generate high-frequency timing events and interrupts. The RTC overflow events trigger:

- Timer0 B3 CCI1B
- ADC conversion trigger when ADCSHSx bits are set as 01b

RTCSS CLOCK SOURCE Reserved 00 01 SMCLK or ACLK is selected(1) 10 XT1CLK **VLOCLK**

表 9-12. RTC Clock Source

Controlled by the RTCCLK bit of the SYSCFG2 register

9.10.12 10-Bit Analog-to-Digital Converter (ADC)

The 10-bit ADC module supports fast 10-bit analog-to-digital conversions with single-ended input. The module implements a 10-bit SAR core, sample select control, a reference generator, and a conversion result buffer. A window comparator with lower and upper limits allows CPU-independent result monitoring with three window comparator interrupt flags.

The ADC supports 10 external inputs and 4 internal inputs (see 表 9-13).

| ADCINCH x | ADC CHANNELS | EXTERNAL PIN |
|-----------|----------------------------|--------------|
| 0 | A0/Veref+ | P1.0 |
| 1 | A1 ⁽¹⁾ | P1.1 |
| 2 | A2/Veref- | P1.2 |
| 3 | A3 | P1.3 |
| 4 | A4 | P2.2 |
| 5 | A5 | P2.3 |
| 6 | A6 | P2.4 |
| 7 | A7 | P2.5 |
| 8 | Not used | N/A |
| 9 | Not used | N/A |
| 10 | Not used | N/A |
| 11 | Not used | N/A |
| 12 | On-chip temperature sensor | N/A |
| 13 | Reference voltage (1.5 V) | N/A |
| 14 | DVSS | N/A |
| 15 | DVCC | N/A |

表 9-13. ADC Channel Connections

Product Folder Links: MSP430FR2422

When A7 is used, the PMM 1.2-V reference voltage can be output to this pin by setting the PMM control register. The 1.2-V voltage can be measured by the A1 channel.

The analog-to-digital conversion can be started by software or a hardware trigger. 表 9-14 lists the trigger sources that are available.

表 9-14. ADC Trigger Signal Connections

| ADC | SHSx | TRIGGER SOURCE |
|--------|---------|------------------------------|
| BINARY | DECIMAL | TRIGGER SOURCE |
| 00 | 0 | ADCSC bit (software trigger) |
| 01 | 1 | RTC event |
| 10 | 2 | TA1.1B |
| 11 | 3 | Reserved |

9.10.13 Embedded Emulation Module (EEM)

The EEM supports real-time in-system debugging. The EEM on these devices has the following features:

- Three hardware triggers or breakpoints on memory access
- One hardware trigger or breakpoint on CPU register write access
- · Up to four hardware triggers can be combined to form complex triggers or breakpoints
- One cycle counter
- Clock control on module level
- · EEM version: S



9.11 Input/Output Diagrams

9.11.1 Port P1 (P1.0 to P1.7) Input/Output With Schmitt Trigger

图 9-3 shows the port diagram. 表 9-15 summarizes the selection of pin function.

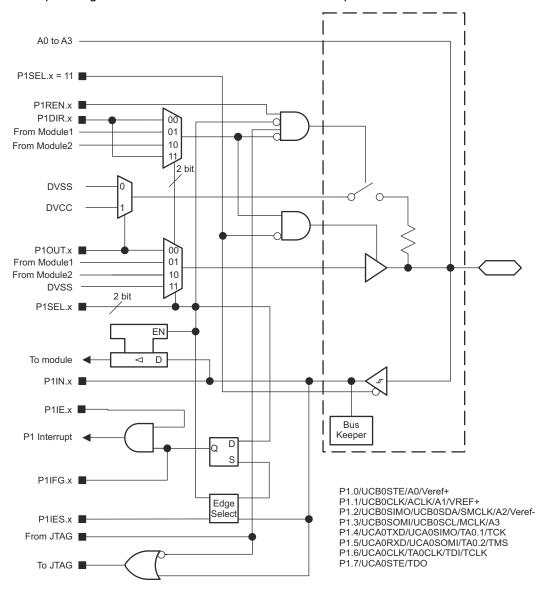


图 9-3. Port P1 (P1.0 to P1.7) Input/Output With Schmitt Trigger

表 9-15. Port P1 (P1.0 to P1.7) Pin Functions

| | | | CONTROL BITS AND SIGNALS ⁽²⁾ | | | | | | | | |
|-------------------------------------|----------|------------------|---|--------------------------------------|-----------------------------------|----------|----|----------|----|----------|----------|
| PIN NAME (P1.x) | x | FUNCTION | P1DIR.x | P1SELx | ANALOG FUNCTION ⁽¹⁾ | JTAG | | | | | |
| | | P1.0 (I/O) | I: 0; O: 1 | 00 | 0 | 0 | | | | | |
| P1.0/UCB0STE/A0/ | 0 | UCB0STE | X | 01 | 0 | 0 | | | | | |
| Veref+ | | A0,Veref+ | Х | ADCPCTLx = 1 (x = 0) from SYSCFG2 | | N/A | | | | | |
| | | P1.1 (I/O) | I: 0; O: 1 | 00 | 0 | 0 | | | | | |
| D4 4/UCD0CLIV/ACLIV/ | | UCB0CLK | X | 01 | 0 | 0 | | | | | |
| P1.1/UCB0CLK/ACLK/ A1/VREF+ | 1 | ACLK | 1 | 10 | 0 | 0 | | | | | |
| | | A1,VREF+ | х | | x = 1 (x = 1) from YSCFG2 | N/A | | | | | |
| | | P1.2 (I/O) | I: 0; O: 1 | 00 | 0 | 0 | | | | | |
| P1.2/UCB0SIMO/ | | UCB0SIMO/UCB0SDA | X | 01 | 0 | 0 | | | | | |
| UCB0SDA/SMCLK/A2/ | 2 | SMCLK | 1 | 10 | 0 | 0 | | | | | |
| Veref- | | A2, Veref- | Х | ADCPCTLx = 1 (x = 2) from SYSCFG2 | | N/A | | | | | |
| | | P1.3 (I/O) | I: 0; O: 1 | 00 | 0 | 0 | | | | | |
| P1.3/UCB0SOMI/ | | UCB0SOMI/UCB0SCL | X | 01 | 0 | 0 | | | | | |
| UCBOSCL/MCLK/A3 | 3 | MCLK | 1 | 10 | 0 | 0 | | | | | |
| | | A3 | Х | | x = 1 (x = 3) from YSCFG2 | N/A | | | | | |
| | | | | P1.4 (I/O) | I: 0; O: 1 | 00 | 0 | Disabled | | | |
| | | UCA0TXD/UCA0SIMO | X | 01 | 0 | Disabled | | | | | |
| P1.4/UCA0TXD/ UCA0SIMO/TA0.1/TCK | 4 | TA0.CCI1A | 0 | 40 | 10 | 10 | 10 | 10 | 0 | Disabled | |
| | | TA0.1 | 1 | - 10 | 0 | Disabled | | | | | |
| | | JTAG TCK | Х | Х | Х | TCK | | | | | |
| | | P1.5 (I/O) | I: 0; O: 1 | 00 | 0 | Disabled | | | | | |
| D4 5/110 4 0 D V D / | | UCA0RXD/UCA0SOMI | X | 01 | 0 | Disabled | | | | | |
| P1.5/UCA0RXD/ UCA0SOMI/TA0.2/TMS | 5 | TA0.CCI2A | 0 | 10 | 10 | 10 | 10 | 10 | 10 | 0 | Disabled |
| | | TA0.2 | 1 | 10 | U | Disabled | | | | | |
| | | JTAG TMS | X | Х | X | TMS | | | | | |
| | | P1.6 (I/O) | I: 0; O: 1 | 00 | 0 | Disabled | | | | | |
| P1.6/UCA0CLK/ | 6 | UCA0CLK | X | 01 | 0 | Disabled | | | | | |
| TA0CLK/TDI/TCLK | | TAOCLK | 0 | 10 | 0 | Disabled | | | | | |
| | | JTAG TDI/TCLK | X | Х | Х | TDI/TCLK | | | | | |
| | | P1.7 (I/O) | I: 0; O: 1 | 00 | 0 | Disabled | | | | | |
| P1.7/UCA0STE/TDO | 7 | UCA0STE | Х | 01 | 0 | Disabled | | | | | |
| | JTAG TDO | X | X | X | TDO | | | | | | |

⁽¹⁾ Setting the bits disables both the output driver and input Schmitt trigger to prevent leakage when analog signals are applied.

⁽²⁾ X = don't care

9.11.2 Port P2 (P2.0 to P2.6) Input/Output With Schmitt Trigger

图 9-4 shows the port diagram. 表 9-16 summarizes the selection of pin function.

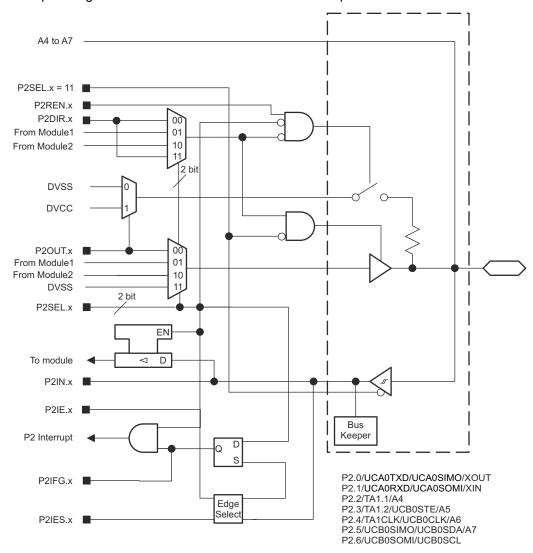


图 9-4. Port P2 (P2.0 to P2.6) Input/Output With Schmitt Trigger

表 9-16. Port P2 (P2.0 to P2.6) Pin Functions

| DINI NIAME (DO w) | | FUNCTION | CON | CONTROL BITS AND SIGNALS ⁽²⁾ | | |
|--------------------------------|----------|------------------|------------|---|---|--|
| PIN NAME (P2.x) x | FUNCTION | P2DIR.x | P2SELx | ANALOG FUNCTION(1 | | |
| | | P2.0 (I/O) | I: 0; O: 1 | 00 | 0 | |
| P2.0/UCA0TXD/ UCA0SIMO/XOUT | 0 | UCA0TXD/UCA0SIMO | X | 01 | 0 | |
| 00/10011110//2001 | | XOUT | X | 10 | 0 | |
| | | P2.1 (I/O) | I: 0; O: 1 | 00 | 0 | |
| P2.1/UCA0RXD/ UCA0SOMI/XIN | 1 | UCA0RXD/UCA0SOMI | X | 01 | 0 | |
| | | XIN | X | 10 | 0 | |
| | | P2.2 (I/O) | I: 0; O: 1 | 00 | 0 | |
| | | TA1.CCI1A | 0 | 01 | 0 | |
| P2.2/TA1.1/A4 | 2 | TA1.1 | 1 | 01 | U | |
| | | A4 | X | Х | ADCPCTLx = 1 (x = 4) from SYSCFG2 ⁽¹⁾ | |
| | | P2.3 (I/O) | I: 0; O: 1 | 00 | 0 | |
| | | TA1.CCI2A | 0 | 01 | 0 | |
| P2.3/TA1.2/ | 3 | TA1.2 | 1 | 01 | 0 | |
| UCB0STE/A5 | | UCB0STE | X | 10 | 0 | |
| | | A5 | х | х | ADCPCTLx = 1 (x = 5) from SYSCFG2 ⁽¹⁾ | |
| | | P2.4 (I/O) | I: 0; O: 1 | 00 | 0 | |
| P2.4/TA1CLK/ | | TA1CLK | 0 | 01 | 0 | |
| UCB0CLK/A6 | 4 | UCB0CLK | X | 10 | 0 | |
| | | A6 | х | Х | ADCPCTLx = 1 (x = 6) from SYSCFG2 ⁽¹⁾ | |
| | | P2.5 (I/O) | I: 0; O: 1 | 00 | 0 | |
| P2.5/UCB0SIMO/ | 5 | UCB0SIMO/UCB0SDA | X | 10 | 0 | |
| UCB0SDA/A7 | A7 | Х | Х | ADCPCTLx = 1 (x = 7) from SYSCFG2 ⁽¹⁾ | | |
| P2.6/UCB0SOMI/ | 6 | P2.6 (I/O) | I: 0; O: 1 | 00 | 0 | |
| JCB0SCL 6 | б | UCB0SOMI/UCB0SCL | X | 10 | 0 | |



9.12 Device Descriptors

 $\frac{1}{2}$ 9-17 lists the Device IDs of the devices. $\frac{1}{2}$ 9-18 lists the contents of the device descriptor tag-length-value (TLV) structure for the devices.

表 9-17. Device IDs

| DEVICE | DEVICE ID | | |
|--------------|-----------|-------|--|
| DEVICE | 1A05h | 1A04h | |
| MSP430FR2422 | 83h | 11h | |

表 9-18. Device Descriptors

| DESCRIPTION | | MSP430FR2422 | | |
|------------------|---------------------------------------|--------------|---------------|--|
| | | ADDRESS | VALUE | |
| | Info length | 1A00h | 06h | |
| | CRC length | 1A01h | 06h | |
| | CRC value ⁽¹⁾ | 1A02h | Per unit | |
| nformation Block | CRC value(**) | 1A03h | Per unit | |
| mormation block | Davis ID | 1A04h | 0 = = 0.47 | |
| | Device ID | 1A05h | - See 表 9-17. | |
| | Hardware revision | 1A06h | Per unit | |
| | Firmware revision | 1A07h | Per unit | |
| | Die record tag | 1A08h | 08h | |
| | Die record length | 1A09h | 0Ah | |
| | | 1A0Ah | Per unit | |
| | Lot wafer ID | 1A0Bh | Per unit | |
| | Lot water 1D | 1A0Ch | Per unit | |
| No Doord | | 1A0Dh | Per unit | |
| Die Record | Die V negitien | 1A0Eh | Per unit | |
| | Die X position | 1A0Fh | Per unit | |
| | Die V neeitien | 1A10h | Per unit | |
| | Die Y position | 1A11h | Per unit | |
| | Test result | 1A12h | Per unit | |
| | lestresuit | 1A13h | Per unit | |
| | ADC calibration tag | 1A14h | Per unit | |
| | ADC calibration length | 1A15h | Per unit | |
| | ADC gain factor | 1A16h | Per unit | |
| | ADC gain factor | 1A17h | Per unit | |
| ADC calibration | ADC offset | 1A18h | Per unit | |
| ADC CAIIDIALION | ADC oliset | 1A19h | Per unit | |
| | ADC 1.5 V reference, temperature 20°C | 1A1Ah | Per unit | |
| | ADC 1.5-V reference, temperature 30°C | 1A1Bh | Per unit | |
| | ADC 1.5 V reference, temperature 95°C | 1A1Ch | Per unit | |
| | ADC 1.5-V reference, temperature 85°C | 1A1Dh | Per unit | |

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表 9-18. Device Descriptors (continued)

| ₹ 5-10. Device Descriptors (continued) | | | | | |
|--|---|---------|--------------|--|--|
| | DESCRIPTION | | MSP430FR2422 | | |
| DESCRIPTION | | ADDRESS | VALUE | | |
| | Calibration tag | 1A1Eh | 12h | | |
| Reference and DCO Calibration | Calibration length | 1A1Fh | 04h | | |
| | 1.5-V reference factor | 1A20h | Per unit | | |
| | | 1A21h | Per unit | | |
| | DCO tap setting for 16 MHz, temperature 30°C ⁽²⁾ | 1A22h | Per unit | | |
| | | 1A23h | Per unit | | |

- (1) The CRC value covers the check sum from 0x1A04h to 0x1AF5h by applying the CRC-CCITT-16 polynomial of $x^{16} + x^{12} + x^5 + 1$.
- (2) This value can be directly loaded into DCO bits in CSCTL0 registers to get accurate 16-MHz frequency at room temperature, especially when the MCU exits from LPM3 and below. TI suggests using the predivider to decrease the frequency if the temperature drift might result an overshoot beyond 16 MHz.

9.13 Memory

9.13.1 Memory Organization

表 9-19 summarizes the memory organization of the devices.

表 9-19. Memory Organization

| & 3-13. Memory Organization | | | | |
|--|---|--|--|--|
| | ACCESS | MSP430FR2422 | | |
| Memory (FRAM) Main: interrupt vectors and signatures Main: code memory | Read/Write (Optional Write Protect) ⁽¹⁾ | 7.25KB FFFFh to FF80h FFFFh to E300h | | |
| RAM | Read/Write | 2KB 27FFh to 2000h | | |
| Information Memory (FRAM) | Read/Write (Optional Write Protect) ⁽²⁾ | 256B 18FFh to 1800h | | |
| Bootloader (BSL1) Memory (ROM) | Read only | 2KB 17FFh to 1000h | | |
| Bootloader (BSL2) Memory (ROM) | Read only | 1KB FFFFFh to FFC00h | | |
| Peripherals | Read/Write | 4KB 0FFFh to 0000h | | |

⁽¹⁾ The Program FRAM can be write protected by setting PFWP bit in SYSCFG0 register. See the SYS chapter in the MP430FR4xx and MP430FR2xx Family User's Guide for more details

⁽²⁾ The Information FRAM can be write protected by setting DFWP bit in SYSCFG0 register. See the SYS chapter in the MP430FR4xx and MP430FR2xx Family User's Guide for more details

9.13.2 Peripheral File Map

表 9-20 lists the available peripherals and the register base address for each.

表 9-20. Peripherals Summary

| MODULE NAME | BASE ADDRESS | SIZE |
|--------------------------------|--------------|-------|
| Special Functions (See 表 9-21) | 0100h | 0010h |
| PMM (See 表 9-22) | 0120h | 0020h |
| SYS (See 表 9-23) | 0140h | 0040h |
| CS (See 表 9-24) | 0180h | 0020h |
| FRAM (See 表 9-25) | 01A0h | 0010h |
| CRC (See 表 9-26) | 01C0h | 0008h |
| WDT (See 表 9-27) | 01CCh | 0002h |
| Port P1, P2 (See 表 9-28) | 0200h | 0020h |
| RTC (See 表 9-29) | 0300h | 0010h |
| Timer0_A3 (See 表 9-30) | 0380h | 0030h |
| Timer1_A3 (See 表 9-31) | 03C0h | 0030h |
| MPY32 (See 表 9-32) | 04C0h | 0030h |
| eUSCI_A0 (See 表 9-33) | 0500h | 0020h |
| eUSCI_B0 (See 表 9-34) | 0540h | 0030h |
| Backup Memory (See 表 9-35) | 0660h | 0020h |
| ADC (See 表 9-36) | 0700h | 0040h |

表 9-21. Special Function Registers (Base Address: 0100h)

| REGISTER DESCRIPTION | ACRONYM | OFFSET |
|-----------------------|---------|--------|
| SFR interrupt enable | SFRIE1 | 00h |
| SFR interrupt flag | SFRIFG1 | 02h |
| SFR reset pin control | SFRRPCR | 04h |

表 9-22. PMM Registers (Base Address: 0120h)

| REGISTER DESCRIPTION | ACRONYM | OFFSET |
|----------------------|---------|--------|
| PMM control 0 | PMMCTL0 | 00h |
| PMM control 1 | PMMCTL1 | 02h |
| PMM control 2 | PMMCTL2 | 04h |
| PMM interrupt flags | PMMIFG | 0Ah |
| PM5 control 0 | PM5CTL0 | 10h |

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表 9-23. SYS Registers (Base Address: 0140h)

| REGISTER DESCRIPTION | ACRONYM | OFFSET |
|-------------------------------|-----------|--------|
| System control | SYSCTL | 00h |
| Bootloader configuration area | SYSBSLC | 02h |
| JTAG mailbox control | SYSJMBC | 06h |
| JTAG mailbox input 0 | SYSJMBI0 | 08h |
| JTAG mailbox input 1 | SYSJMBI1 | 0Ah |
| JTAG mailbox output 0 | SYSJMBO0 | 0Ch |
| JTAG mailbox output 1 | SYSJMBO1 | 0Eh |
| Bus error vector generator | SYSBERRIV | 18h |
| User NMI vector generator | SYSUNIV | 1Ah |
| System NMI vector generator | SYSSNIV | 1Ch |
| Reset vector generator | SYSRSTIV | 1Eh |
| System configuration 0 | SYSCFG0 | 20h |
| System configuration 1 | SYSCFG1 | 22h |
| System configuration 2 | SYSCFG2 | 24h |

表 9-24. CS Registers (Base Address: 0180h)

| REGISTER DESCRIPTION | ACRONYM | OFFSET |
|----------------------|---------|--------|
| CS control 0 | CSCTL0 | 00h |
| CS control 1 | CSCTL1 | 02h |
| CS control 2 | CSCTL2 | 04h |
| CS control 3 | CSCTL3 | 06h |
| CS control 4 | CSCTL4 | 08h |
| CS control 5 | CSCTL5 | 0Ah |
| CS control 6 | CSCTL6 | 0Ch |
| CS control 7 | CSCTL7 | 0Eh |
| CS control 8 | CSCTL8 | 10h |

表 9-25. FRAM Registers (Base Address: 01A0h)

| REGISTER DESCRIPTION | ACRONYM | OFFSET |
|----------------------|---------|--------|
| FRAM control 0 | FRCTL0 | 00h |
| General control 0 | GCCTL0 | 04h |
| General control 1 | GCCTL1 | 06h |

表 9-26. CRC Registers (Base Address: 01C0h)

| REGISTER DESCRIPTION | ACRONYM | OFFSET |
|-------------------------------|-----------|--------|
| CRC data input | CRC16DI | 00h |
| CRC data input reverse byte | CRCDIRB | 02h |
| CRC initialization and result | CRCINIRES | 04h |
| CRC result reverse byte | CRCRESR | 06h |

表 9-27. WDT Registers (Base Address: 01CCh)

| REGISTER DESCRIPTION | ACRONYM | OFFSET |
|------------------------|---------|--------|
| Watchdog timer control | WDTCTL | 00h |



表 9-28. Port P1, P2 Registers (Base Address: 0200h)

| REGISTER DESCRIPTION | ACRONYM | OFFSET |
|-------------------------------|---------|--------|
| Port P1 input | P1IN | 00h |
| Port P1 output | P1OUT | 02h |
| Port P1 direction | P1DIR | 04h |
| Port P1 pulling enable | P1REN | 06h |
| Port P1 selection 0 | P1SEL0 | 0Ah |
| Port P1 selection 1 | P1SEL1 | 0Ch |
| Port P1 interrupt vector word | P1IV | 0Eh |
| Port P1 interrupt edge select | P1IES | 18h |
| Port P1 complement selection | P1SELC | 16h |
| Port P1 interrupt enable | P1IE | 1Ah |
| Port P1 interrupt flag | P1IFG | 1Ch |
| Port P2 input | P2IN | 01h |
| Port P2 output | P2OUT | 03h |
| Port P2 direction | P2DIR | 05h |
| Port P2 pulling enable | P2REN | 07h |
| Port P2 selection 0 | P2SEL0 | 0Bh |
| Port P2 selection 1 | P2SEL1 | 0Ch |
| Port P2 complement selection | P2SELC | 17h |
| Port P2 interrupt vector word | P2IV | 1Eh |
| Port P2 interrupt edge select | P2IES | 19h |
| Port P2 interrupt enable | P2IE | 1Bh |
| Port P2 interrupt flag | P2IFG | 1Dh |

表 9-29. RTC Registers (Base Address: 0300h)

| REGISTER DESCRIPTION | ACRONYM | OFFSET |
|----------------------|---------|--------|
| RTC control | RTCCTL | 00h |
| RTC interrupt vector | RTCIV | 04h |
| RTC modulo | RTCMOD | 08h |
| RTC counter | RTCCNT | 0Ch |

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表 9-30. Timer0_A3 Registers (Base Address: 0380h)

| ₹ 5-50. Tilliero_A5 Registers (base Address. 550001) | | |
|--|----------|--------|
| REGISTER DESCRIPTION | ACRONYM | OFFSET |
| TA0 control | TA0CTL | 00h |
| Capture/compare control 0 | TA0CCTL0 | 02h |
| Capture/compare control 1 | TA0CCTL1 | 04h |
| Capture/compare control 2 | TA0CCTL2 | 06h |
| TA0 counter | TA0R | 10h |
| Capture/compare 0 | TA0CCR0 | 12h |
| Capture/compare 1 | TA0CCR1 | 14h |
| Capture/compare 2 | TA0CCR2 | 16h |
| TA0 expansion 0 | TA0EX0 | 20h |
| TA0 interrupt vector | TAOIV | 2Eh |

表 9-31. Timer1_A3 Registers (Base Address: 03C0h)

| REGISTER DESCRIPTION | ACRONYM | OFFSET |
|---------------------------|----------|--------|
| TA1 control | TA1CTL | 00h |
| Capture/compare control 0 | TA1CCTL0 | 02h |
| Capture/compare control 1 | TA1CCTL1 | 04h |
| Capture/compare control 2 | TA1CCTL2 | 06h |
| TA1 counter | TA1R | 10h |
| Capture/compare 0 | TA1CCR0 | 12h |
| Capture/compare 1 | TA1CCR1 | 14h |
| Capture/compare 2 | TA1CCR2 | 16h |
| TA1 expansion 0 | TA1EX0 | 20h |
| TA1 interrupt vector | TA1IV | 2Eh |



表 9-32. MPY32 Registers (Base Address: 04C0h)

| REGISTER DESCRIPTION | ACRONYM | OFFSET |
|---|-----------|--------|
| 16-bit operand 1 - multiply | MPY | 00h |
| 16-bit operand 1 - signed multiply | MPYS | 02h |
| 16-bit operand 1 - multiply accumulate | MAC | 04h |
| 16-bit operand 1 - signed multiply accumulate | MACS | 06h |
| 16-bit operand 2 | OP2 | 08h |
| 16 × 16 result low word | RESLO | 0Ah |
| 16 × 16 result high word | RESHI | 0Ch |
| 16 × 16 sum extension | SUMEXT | 0Eh |
| 32-bit operand 1 - multiply low word | MPY32L | 10h |
| 32-bit operand 1 - multiply high word | MPY32H | 12h |
| 32-bit operand 1 - signed multiply low word | MPYS32L | 14h |
| 32-bit operand 1 - signed multiply high word | MPYS32H | 16h |
| 32-bit operand 1 - multiply accumulate low word | MAC32L | 18h |
| 32-bit operand 1 - multiply accumulate high word | MAC32H | 1Ah |
| 32-bit operand 1 - signed multiply accumulate low word | MACS32L | 1Ch |
| 32-bit operand 1 - signed multiply accumulate high word | MACS32H | 1Eh |
| 32-bit operand 2 - low word | OP2L | 20h |
| 32-bit operand 2 - high word | OP2H | 22h |
| 32 × 32 result 0 - least significant word | RES0 | 24h |
| 32 × 32 result 1 | RES1 | 26h |
| 32 × 32 result 2 | RES2 | 28h |
| 32 × 32 result 3 - most significant word | RES3 | 2Ah |
| MPY32 control 0 | MPY32CTL0 | 2Ch |

表 9-33. eUSCI A0 Registers (Base Address: 0500h)

| REGISTER DESCRIPTION | ACRONYM | OFFSET |
|-------------------------------|-------------|--------|
| eUSCI_A control word 0 | UCA0CTLW0 | 00h |
| eUSCI_A control word 1 | UCA0CTLW1 | 02h |
| eUSCI_A control rate 0 | UCA0BR0 | 06h |
| eUSCI_A control rate 1 | UCA0BR1 | 07h |
| eUSCI_A modulation control | UCA0MCTLW | 08h |
| eUSCI_A status | UCA0STAT | 0Ah |
| eUSCI_A receive buffer | UCA0RXBUF | 0Ch |
| eUSCI_A transmit buffer | UCA0TXBUF | 0Eh |
| eUSCI_A LIN control | UCA0ABCTL | 10h |
| eUSCI_A IrDA transmit control | IUCA0IRTCTL | 12h |
| eUSCI_A IrDA receive control | IUCA0IRRCTL | 13h |
| eUSCI_A interrupt enable | UCA0IE | 1Ah |
| eUSCI_A interrupt flags | UCA0IFG | 1Ch |
| eUSCI_A interrupt vector word | UCA0IV | 1Eh |

表 9-34. eUSCI_B0 Registers (Base Address: 0540h)

| REGISTER DESCRIPTION | ACRONYM | OFFSET | | |
|--------------------------------|-------------|--------|--|--|
| eUSCI_B control word 0 | UCB0CTLW0 | 00h | | |
| eUSCI_B control word 1 | UCB0CTLW1 | 02h | | |
| eUSCI_B bit rate 0 | UCB0BR0 | 06h | | |
| eUSCI_B bit rate 1 | UCB0BR1 | 07h | | |
| eUSCI_B status word | UCB0STATW | 08h | | |
| eUSCI_B byte counter threshold | UCB0TBCNT | 0Ah | | |
| eUSCI_B receive buffer | UCB0RXBUF | 0Ch | | |
| eUSCI_B transmit buffer | UCB0TXBUF | 0Eh | | |
| eUSCI_B I2C own address 0 | UCB0I2COA0 | 14h | | |
| eUSCI_B I2C own address 1 | UCB0I2COA1 | 16h | | |
| eUSCI_B I2C own address 2 | UCB0I2COA2 | 18h | | |
| eUSCI_B I2C own address 3 | UCB0I2COA3 | 1Ah | | |
| eUSCI_B receive address | UCB0ADDRX | 1Ch | | |
| eUSCI_B address mask | UCB0ADDMASK | 1Eh | | |
| eUSCI_B I2C slave address | UCB0I2CSA | 20h | | |
| eUSCI_B interrupt enable | UCB0IE | 2Ah | | |
| eUSCI_B interrupt flags | UCB0IFG | 2Ch | | |
| eUSCI_B interrupt vector word | UCB0IV | 2Eh | | |



表 9-35. Backup Memory Registers (Base Address: 0660h)

| REGISTER DESCRIPTION | ACRONYM | OFFSET | | |
|----------------------|----------|--------|--|--|
| Backup memory 0 | BAKMEM0 | 00h | | |
| Backup memory 1 | BAKMEM1 | 02h | | |
| Backup memory 2 | BAKMEM2 | 04h | | |
| Backup memory 3 | ВАКМЕМ3 | 06h | | |
| Backup memory 4 | BAKMEM4 | 08h | | |
| Backup memory 5 | BAKMEM5 | 0Ah | | |
| Backup memory 6 | BAKMEM6 | 0Ch | | |
| Backup memory 7 | BAKMEM7 | 0Eh | | |
| Backup memory 8 | BAKMEM8 | 10h | | |
| Backup memory 9 | BAKMEM9 | 12h | | |
| Backup memory 10 | BAKMEM10 | 14h | | |
| Backup memory 11 | BAKMEM11 | 16h | | |
| Backup memory 12 | BAKMEM12 | 18h | | |
| Backup memory 13 | BAKMEM13 | 1Ah | | |
| Backup memory 14 | BAKMEM14 | 1Ch | | |
| Backup memory 15 | BAKMEM15 | 1Eh | | |

表 9-36. ADC Registers (Base Address: 0700h)

| REGISTER DESCRIPTION | REGISTER | OFFSET | | |
|--------------------------------------|----------|--------------------------|--|--|
| ADC control 0 | ADCCTL0 | 00h | | |
| ADC control 1 | ADCCTL1 | 02h | | |
| ADC control 2 | ADCCTL2 | 04h 06h 08h 0Ah | | |
| ADC window comparator low threshold | ADCLO | | | |
| ADC window comparator high threshold | ADCHI | | | |
| ADC memory control 0 | ADCMCTL0 | | | |
| ADC conversion memory | ADCMEM0 | 12h | | |
| ADC interrupt enable | ADCIE | 1Ah | | |
| ADC interrupt flags | ADCIFG | 1Ch | | |
| ADC interrupt vector word | ADCIV | 1Eh | | |

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9.14 Identification

9.14.1 Revision Identification

The device revision information is included as part of the top-side marking on the device package. The device-specific errata sheet describes these markings.

The hardware revision is also stored in the Device Descriptor structure in the Info Block section. For details on this value, see the Hardware Revision entries in \ddagger 9.12.

9.14.2 Device Identification

The device type can be identified from the top-side marking on the device package. The device-specific errata sheet describes these markings.

A device identification value is also stored in the Device Descriptor structure in the Info Block section. For details on this value, see the Device ID entries in \ddagger 9.12.

9.14.3 JTAG Identification

Programming through the JTAG interface, including reading and identifying the JTAG ID, is described in detail in MSP430 Programming With the JTAG Interface.

10 Applications, Implementation, and Layout

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

10.1 Device Connection and Layout Fundamentals

This section discusses the recommended guidelines when designing with the MSP430 devices. These guidelines are to make sure that the device has proper connections for powering, programming, debugging, and optimum analog performance.

10.1.1 Power Supply Decoupling and Bulk Capacitors

TI recommends connecting a combination of a 10-µF plus a 100-nF low-ESR ceramic decoupling capacitor to the DVCC and DVSS pins. Higher-value capacitors may be used but can impact supply rail ramp-up time. Decoupling capacitors must be placed as close as possible to the pins that they decouple (within a few millimeters). Additionally, TI recommends separated grounds with a single-point connection for better noise isolation from digital-to-analog circuits on the board and to achieve high analog accuracy.

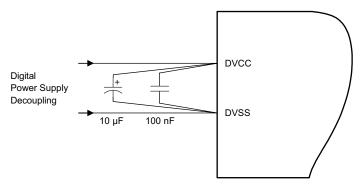


图 10-1. Power Supply Decoupling

10.1.2 External Oscillator

This device supports only a low-frequency crystal (32 kHz) on the XIN and XOUT pins. External bypass capacitors for the crystal oscillator pins are required.

It is also possible to apply digital clock signals to the XIN input pin that meet the specifications of the respective oscillator if the appropriate XT1BYPASS mode is selected. In this case, the associated XOUT pin can be used for other purposes. If the XIN and XOUT pins are not used, they must be terminated according to †7.6.

图 10-2 shows a typical connection diagram.

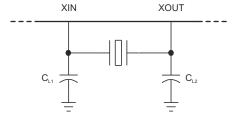


图 10-2. Typical Crystal Connection

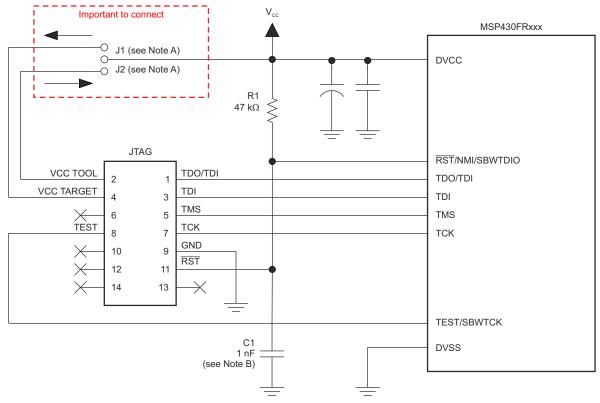
See MSP430 32-kHz Crystal Oscillators for more information on selecting, testing, and designing a crystal oscillator with the MSP430 devices.

10.1.3 JTAG

With the proper connections, the debugger and a hardware JTAG interface (such as the MSP-FET or MSP-FET430UIF) can be used to program and debug code on the target board. In addition, the connections also support the MSP-GANG production programmers, thus providing an easy way to program prototype boards, if desired. 图 10-3 shows the connections between the 14-pin JTAG connector and the target device required to support in-system programming and debugging for 4-wire JTAG communication. 图 10-4 shows the connections for 2-wire JTAG mode (Spy-Bi-Wire).

The connections for the MSP-FET and MSP-FET430UIF interface modules and the MSP-GANG are identical. Both can supply V_{CC} to the target board (through pin 2). In addition, the MSP-FET and MSP-FET430UIF interface modules and MSP-GANG have a V_{CC} sense feature that, if used, requires an alternate connection (pin 4 instead of pin 2). The V_{CC} sense feature detects the local V_{CC} present on the target board (that is, a battery or other local power supply) and adjusts the output signals accordingly. \boxtimes 10-3 and \boxtimes 10-4 show a jumper block that supports both scenarios of supplying V_{CC} to the target board. If this flexibility is not required, the desired V_{CC} connections may be hard-wired to eliminate the jumper block. Pins 2 and 4 must not be connected at the same time.

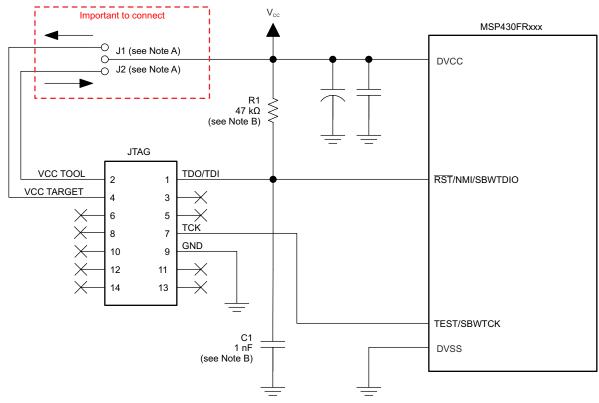
For additional design information regarding the JTAG interface, see the MSP430 Hardware Tools User's Guide.



- A. If a local target power supply is used, make connection J1. If power from the debug or programming adapter is used, make connection J2.
- B. The upper limit for C1 is 1.1 nF when using current TI tools.

图 10-3. Signal Connections for 4-Wire JTAG Communication





- A. Make connection J1 if a local target power supply is used, or make connection J2 if the target is powered from the debug or programming adapter.
- B. The device RST/NMI/SBWTDIO pin is used in 2-wire mode for bidirectional communication with the device during JTAG access, and any capacitance that is attached to this signal may affect the ability to establish a connection with the device. The upper limit for C1 is 1.1 nF when using current TI tools.

图 10-4. Signal Connections for 2-Wire JTAG Communication (Spy-Bi-Wire)

10.1.4 Reset

The reset pin can be configured as a reset function (default) or as an NMI function in the Special Function Register (SFR), SFRRPCR.

In reset mode, the \overline{RST}/NMI pin is active low, and a pulse applied to this pin that meets the reset timing specifications generates a BOR-type device reset.

Setting SYSNMI causes the RST/NMI pin to be configured as an external NMI source. The external NMI is edge sensitive, and its edge is selectable by SYSNMIIES. Setting the NMIIE enables the interrupt of the external NMI. When an external NMI event occurs, the NMIIFG is set.

The $\overline{\text{RST}}/\text{NMI}$ pin can have either a pullup or pulldown that is enabled or not. SYSRSTUP selects either pullup or pulldown, and SYSRSTRE causes the pullup (default) or pulldown to be enabled (default) or not. If the $\overline{\text{RST}}/\text{NMI}$ pin is unused, it is required either to select and enable the internal pullup or to connect an external 47-k Ω pullup resistor to the $\overline{\text{RST}}/\text{NMI}$ pin with a 10-nF pulldown capacitor. The pulldown capacitor should not exceed 1.1 nF when using devices with Spy-Bi-Wire interface in Spy-Bi-Wire mode or in 4-wire JTAG mode with TI tools like FET interfaces or GANG programmers.

See the MP430FR4xx and MP430FR2xx Family User's Guide for more information on the referenced control registers and bits.

10.1.5 Unused Pins

For details on the connection of unused pins, see # 7.6.

10.1.6 General Layout Recommendations

- Proper grounding and short traces for external crystal to reduce parasitic capacitance. See MSP430 32-kHz
 Crystal Oscillators for recommended layout guidelines.
- Proper bypass capacitors on DVCC and reference pins, if used.
- Avoid routing any high-frequency signal close to an analog signal line. For example, keep digital switching signals such as PWM or JTAG signals away from the oscillator circuit.
- Proper ESD level protection should be considered to protect the device from unintended high-voltage electrostatic discharge. See MSP430 System-Level ESD Considerations for guidelines.

10.1.7 Do's and Don'ts

During power up, power down, and device operation, DVCC must not exceed the limits specified in 节 8.1. Exceeding the specified limits may cause malfunction of the device including erroneous writes to RAM and FRAM.

10.2 Peripheral- and Interface-Specific Design Information

10.2.1 ADC Peripheral

10.2.1.1 Partial Schematic

🛮 10-5 shows the recommended decoupling circuit when an external voltage reference is used.

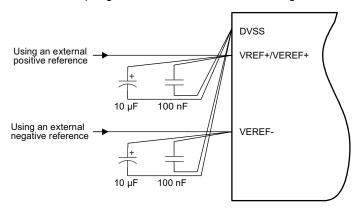


图 10-5. ADC Grounding and Noise Considerations

10.2.1.2 Design Requirements

As with any high-resolution ADC, appropriate printed-circuit-board layout and grounding techniques should be followed to eliminate ground loops, unwanted parasitic effects, and noise.

Ground loops are formed when return current from the ADC flows through paths that are common with other analog or digital circuitry. If care is not taken, this current can generate small unwanted offset voltages that can add to or subtract from the reference or input voltages of the ADC. The general guidelines in 节 10.1.1 combined with the connections shown in 图 10-5 prevent this.

Quickly switching digital signals and noisy power supply lines can corrupt the conversion results, so keep the ADC input trace shielded from those digital and power supply lines. Putting the MCU in low-power mode during the ADC conversion improves the ADC performance in a noisy environment. If the device includes the analog power pair inputs (AVCC and AVSS), TI recommends a noise-free design using separate analog and digital ground planes with a single-point connection to achieve high accuracy.

☑ 10-5 shows the recommended decoupling circuit when an external voltage reference is used. The internal reference module has a maximum drive current as described in the sections ADC Pin Enable and 1.2-V Reference Settings of the MSP430FR4xx and MSP430FR2xx Family User's Guide.

The reference voltage must be a stable voltage for accurate measurements. The capacitor values that are selected in the general guidelines filter out the high- and low-frequency ripple before the reference voltage

enters the device. In this case, the 10-µF capacitor buffers the reference pin and filters any low-frequency ripple. A bypass capacitor of 100 nF filters out any high-frequency noise.

10.2.1.3 Layout Guidelines

Components that are shown in the partial schematic (see 🖺 10-5) should be placed as close as possible to the respective device pins to avoid long traces, because they add additional parasitic capacitance, inductance, and resistance on the signal.

Avoid routing analog input signals close to a high-frequency pin (for example, a high-frequency PWM), because the high-frequency switching can be coupled into the analog signal.

11 Device and Documentation Support

11.1 Getting Started and Next Steps

For more information on the MSP low-power microcontrollers and the tools and libraries that are available to help with your development, visit the MSP430™ ultra-low-power sensing & measurement MCUs overview.

11.2 Device Nomenclature

To designate the stages in the product development cycle, TI assigns prefixes to the part numbers of all MSP MCU devices. Each MSP MCU commercial family member has one of two prefixes: MSP or XMS. These prefixes represent evolutionary stages of product development from engineering prototypes (XMS) through fully qualified production devices (MSP).

- **XMS** Experimental device that is not necessarily representative of the final device's electrical specifications
- MSP Fully qualified production device

XMS devices are shipped against the following disclaimer:

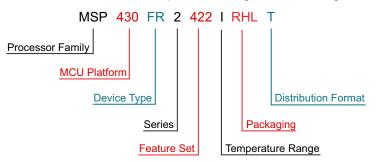
"Developmental product is intended for internal evaluation purposes."

MSP devices have been characterized fully, and the quality and reliability of the device have been demonstrated fully. TI's standard warranty applies.

Predictions show that prototype devices (XMS) have a greater failure rate than the standard production devices. TI recommends that these devices not be used in any production system because their expected end-use failure rate still is undefined. Only qualified production devices are to be used.

TI device nomenclature also includes a suffix with the device family name. This suffix indicates the temperature range, package type, and distribution format.

11-1 provides a legend for reading the complete device name.



| Processor Family | MSP = Mixed-Signal Processor XMS = Experimental Silicon | | | |
|---------------------|---|--|--|--|
| MCU Platform | 430 = MSP430 16-bit low-power platform | | | |
| Device Type | Memory Type FR = FRAM | | | |
| Series | 2 = Up to 16 MHz without LCD | | | |
| Feature Set | First and Second Digits: ADC10 Channels / eUSCIs / 16-bit Timers / I/Os 42 = Up to 8 / 2 / 2 / Up to 15 | Third Digit: FRAM (KB) / SRAM (KB) 2 = 8 / 2 | | |
| Temperature Range | I = -40°C to 85°C | | | |
| Packaging | www.ti.com/packaging | | | |
| Distribution Format | T = Small reel R = Large reel No Marking = Tube or tray | | | |

图 11-1. Device Nomenclature

11.3 Tools and Software

表 11-1 lists the debug features supported by these microcontrollers. See the *Code Composer Studio IDE for MSP430 MCUs User's Guide* for details on the available features.

表 11-1. Hardware Features

| MSP430 ARCHITECTURE | 4-WIRE JTAG | 2-WIRE JTAG | BREAK- POINTS (N) | RANGE BREAK- POINTS | CLOCK CONTROL | STATE SEQUENCER | TRACE BUFFER | LPMx.5 DEBUGGING SUPPORT | EEM VERSION |
|------------------------|----------------|----------------|-------------------------|---------------------------|------------------|--------------------|-----------------|--------------------------------|----------------|
| MSP430Xv2 | Yes | Yes | 3 | Yes | Yes | No | No | No | S |

Design Kits and Evaluation Modules

MSP-TS430RHL20 20-Pin Target Development Board for MSP430FR2x MCUs

The MSP-TS430RHL20 is a stand-alone ZIF socket target board used to program and debug the MSP430 insystem through the JTAG interface or the Spy Bi-Wire (2-wire JTAG) protocol. The development board supports all MSP430FR252x and MSP430FR242x Flash parts in a 20-pin VQFN package (TI package code: RHL).

MSP-FET + MSP-TS430RHL20 FRAM Microcontroller Development Kit Bundle

The MSP-FET430RHL20-BNDL bundle combines two debugging tools that support the 20-pin RHL package for the MSP430FR2422 microcontroller (for example, MSP430FR2422RHL). These two tools include MSP-TS430RHL20 and MSP-FET.

Software

MSP430Ware[™] Software

MSP430Ware software is a collection of code examples, data sheets, and other design resources for all MSP430 devices delivered in a convenient package. In addition to providing a complete collection of existing MSP430 design resources, MSP430Ware software also includes a high-level API called MSP430 Driver Library. This library makes it easy to program MSP430 hardware. MSP430Ware software is available as a component of CCS or as a stand-alone package.

MSP430FR2422 Code Examples

C Code examples are available for every MSP device that configures each of the integrated peripherals for various application needs.

MSP Driver Library

Driver Library's abstracted API keeps you above the bits and bytes of the MSP430 hardware by providing easy-to-use function calls. Thorough documentation is delivered through a helpful API Guide, which includes details on each function call and the recognized parameters. Developers can use Driver Library functions to write complete projects with minimal overhead.

MSP EnergyTrace[™] Technology

EnergyTrace technology for MSP430 microcontrollers is an energy-based code analysis tool that measures and displays the application's energy profile and helps to optimize it for ultra-low-power consumption.

ULP (Ultra-Low Power) Advisor

ULP Advisor™ software is a tool for guiding developers to write more efficient code to fully utilize the unique ultra-low power features of MSP and MSP432 microcontrollers. Aimed at both experienced and new microcontroller developers, ULP Advisor checks your code against a thorough ULP checklist to squeeze every last nano amp out of your application. At build time, ULP Advisor will provide notifications and remarks to highlight areas of your code that can be further optimized for lower power.

Submit Document Feedback

FRAM Embedded Software Utilities for MSP Ultra-Low-Power Microcontrollers

The FRAM Utilities is designed to grow as a collection of embedded software utilities that leverage the ultra-low-power and virtually unlimited write endurance of FRAM. The utilities are available for MSP430FRxx FRAM microcontrollers and provide example code to help start application development. Included utilities include Compute Through Power Loss (CTPL). CTPL is utility API set that enables ease of use with LPMx.5 low-power modes and a powerful shutdown mode that allows an application to save and restore critical system components when a power loss is detected.

IEC60730 Software Package

The IEC60730 MSP430 software package was developed to be useful in assisting customers in complying with IEC 60730-1:2010 (Automatic Electrical Controls for Household and Similar Use – Part 1: General Requirements) for up to Class B products, which includes home appliances, arc detectors, power converters, power tools, e-bikes, and many others. The IEC60730 MSP430 software package can be embedded in customer applications running on MSP430s to help simplify the customer's certification efforts of functional safety-compliant consumer devices to IEC 60730-1:2010 Class B.

Fixed Point Math Library for MSP

The MSP IQmath and Qmath Libraries are a collection of highly optimized and high-precision mathematical functions for C programmers to seamlessly port a floating-point algorithm into fixed-point code on MSP430 and MSP432 devices. These routines are typically used in computationally intensive real-time applications where optimal execution speed, high accuracy, and ultra-low energy are critical. By using the IQmath and Qmath libraries, it is possible to achieve execution speeds considerably faster and energy consumption considerably lower than equivalent code written using floating-point math.

Floating Point Math Library for MSP430

Continuing to innovate in the low power and low cost microcontroller space, TI brings you MSPMATHLIB. Leveraging the intelligent peripherals of our devices, this floating point math library of scalar functions brings you up to 26x better performance. Mathlib is easy to integrate into your designs. This library is free and is integrated in both Code Composer Studio and IAR IDEs. Read the user's guide for an in depth look at the math library and relevant benchmarks.

Development Tools

Code Composer Studio™ Integrated Development Environment for MSP Microcontrollers

Code Composer Studio is an integrated development environment (IDE) that supports all MSP microcontroller devices. Code Composer Studio comprises a suite of embedded software utilities used to develop and debug embedded applications. It includes an optimizing C/C++ compiler, source code editor, project build environment, debugger, profiler, and many other features. The intuitive IDE provides a single user interface taking you through each step of the application development flow. Familiar utilities and interfaces allow users to get started faster than ever before. Code Composer Studio combines the advantages of the Eclipse software framework with advanced embedded debug capabilities from TI resulting in a compelling feature-rich development environment for embedded developers. When using CCS with an MSP MCU, a unique and powerful set of plugins and embedded software utilities are made available to fully leverage the MSP microcontroller.

Command-Line Programmer

MSP Flasher is an open-source shell-based interface for programming MSP microcontrollers through a FET programmer or eZ430 using JTAG or Spy-Bi-Wire (SBW) communication. MSP Flasher can download binary files (.txt or .hex) files directly to the MSP microcontroller without an IDE.

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MSP MCU Programmer and Debugger

The MSP-FET is a powerful emulation development tool – often called a debug probe – that lets users quickly begin application development on MSP low-power microcontrollers (MCU). Creating MCU software usually requires downloading the resulting binary program to the MSP device for validation and debugging. The MSP-FET provides a debug communication pathway between a host computer and the target MSP. Furthermore, the MSP-FET also provides a backchannel UART connection between the computer's USB interface and the MSP UART. This affords the MSP programmer a convenient method for communicating serially between the MSP and a terminal running on the computer.

MSP-GANG Production Programmer

The MSP Gang Programmer can program up to eight identical MSP430 or MSP432 flash or FRAM devices at the same time. The MSP Gang Programmer connects to a host PC using a standard RS-232 or USB connection and provides flexible programming options that allow the user to fully customize the process. The MSP Gang Programmer is provided with an expansion board, called the Gang Splitter, that implements the interconnections between the MSP Gang Programmer and multiple target devices.

11.4 Documentation Support

The following documents describe the MSP430FR2422 microcontrollers. Copies of these documents are available on the Internet at www.ti.com.

Receiving Notification of Document Updates

To receive notification of documentation updates—including silicon errata—go to the product folder for your device on ti.com (for example, MSP430FR2422). In the upper right corner, click the "Alert me" button. This registers you to receive a weekly digest of product information that has changed (if any). For change details, check the revision history of any revised document.

Errata

MSP430FR2422 Device Erratasheet

Describes the known exceptions to the functional specifications for all silicon revisions of this device.

User's Guides

MSP430FR4xx and MSP430FR2xx Family User's Guide

Detailed description of all modules and peripherals available in this device family.

MSP430 FRAM Device Bootloader (BSL) User's Guide

The BSL can program memory during MSP430 MCU project development and updates. The BSL can be activated by a utility that sends commands using a serial protocol. The BSL enables the user to control the activity of the MSP430 device and to exchange data using a personal computer or other device.

MSP430 Programming With the JTAG Interface

This document describes the functions that are required to erase, program, and verify the memory module of the MSP430 flash-based and FRAM-based microcontroller families using the JTAG communication port. In addition, it describes how to program the JTAG access security fuse that is available on all MSP430 devices. This document describes device access using both the standard 4-wire JTAG interface and the 2-wire JTAG interface, which is also referred to as Spy-Bi-Wire (SBW).

MSP430 Hardware Tools User's Guide

This manual describes the hardware of the TI MSP-FET430 Flash Emulation Tool (FET). The FET is the program development tool for the MSP430 ultra-low-power microcontroller.

Application Reports

MSP430 32-kHz Crystal Oscillators

Selection of the right crystal, correct load circuit, and proper board layout are important for a stable crystal oscillator. This application report summarizes crystal oscillator function and explains the parameters to select the correct crystal for MSP430 ultra-low-power operation. In addition, hints and examples for correct board layout are given. The document also contains detailed information on the possible oscillator tests to ensure stable oscillator operation in mass production.

MSP430 System-Level ESD Considerations

System-level ESD has become increasingly demanding with silicon technology scaling towards lower voltages and the need for designing cost-effective and ultra-low-power components. This application report addresses different ESD topics to help board designers and OEMs understand and design robust system-level designs. A few real-world system-level ESD protection design examples and their results are also discussed.

11.5 支持资源

TI E2E™ 支持论坛是工程师的重要参考资料,可直接从专家获得快速、经过验证的解答和设计帮助。搜索现有解答或提出自己的问题可获得所需的快速设计帮助。

链接的内容由各个贡献者"按原样"提供。这些内容并不构成 TI 技术规范,并且不一定反映 TI 的观点;请参阅 TI 的《使用条款》。

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ESD 的损坏小至导致微小的性能降级,大至整个器件故障。精密的集成电路可能更容易受到损坏,这是因为非常细微的参数更改都可能会导致器件与其发布的规格不相符。

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11.9 术语表

TI术语表本本术语表列出并解释了术语、首字母缩略词和定义。



12 Mechanical, Packaging, and Orderable Information

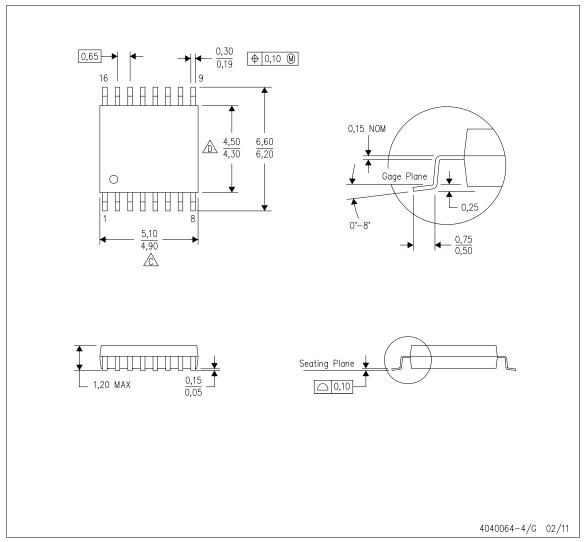
The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, see the left-hand navigation.



MECHANICAL DATA

PW (R-PDSO-G16)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.

 B. This drawing is subject to change without notice.

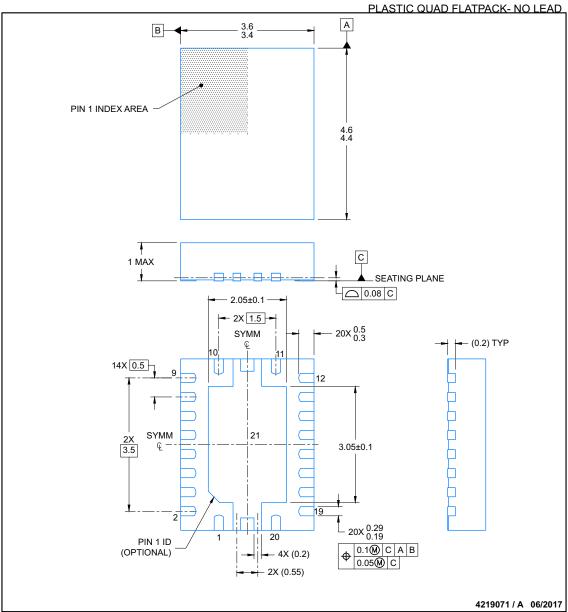
 Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
- E. Falls within JEDEC MO-153



PACKAGE OUTLINE

RHI 0020A

VQFN - 1 mm max height



- NOTES:
 - All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 This drawing is subject to change without notice.

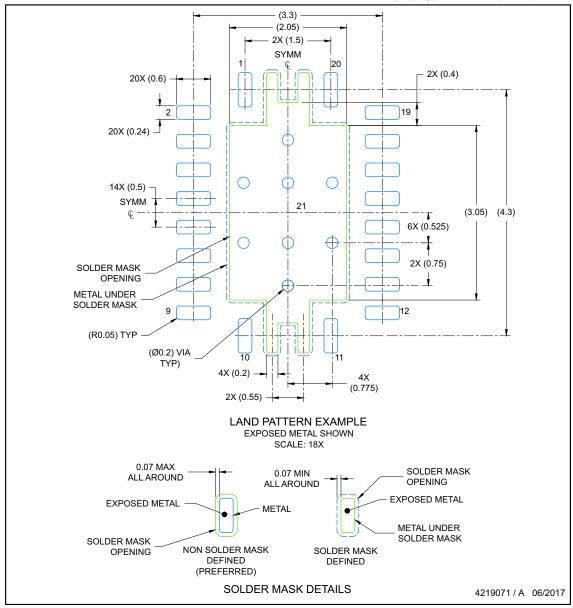
 The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

EXAMPLE BOARD LAYOUT

RHL0020A

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK- NO LEAD



NOTES: (continued)

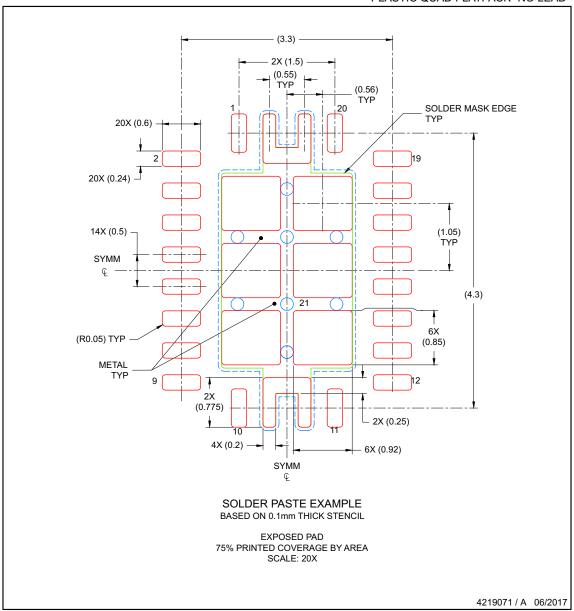
- This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments
 literature number SLUA271 (www.ti.com/lit/slua271).
- 5. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
- Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to theri locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



RHL0020A

EXAMPLE STENCIL DESIGN VQFN - 1 mm max height

PLASTIC QUAD FLATPACK- NO LEAD



NOTES: (continued)

7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations..

www.ti.com 9-Nov-2025

PACKAGING INFORMATION

| Orderable part number | Status | Material type | Package Pins | Package qty Carrier | RoHS | Lead finish/ Ball material | MSL rating/ Peak reflow | Op temp (°C) | Part marking |
|-----------------------|--------|---------------|-----------------|-----------------------|------|-------------------------------|----------------------------|--------------|--------------|
| | (1) | (2) | | | (3) | (4) | (5) | | (6) |
| MSP430FR2422IPW16 | Active | Production | TSSOP (PW) 16 | 90 TUBE | Yes | NIPDAU | Level-2-260C-1 YEAR | -40 to 85 | FR2422 |
| MSP430FR2422IPW16.A | Active | Production | TSSOP (PW) 16 | 90 TUBE | Yes | NIPDAU | Level-2-260C-1 YEAR | -40 to 85 | FR2422 |
| MSP430FR2422IPW16R | Active | Production | TSSOP (PW) 16 | 2000 LARGE T&R | Yes | NIPDAU | Level-2-260C-1 YEAR | -40 to 85 | FR2422 |
| MSP430FR2422IPW16R.A | Active | Production | TSSOP (PW) 16 | 2000 LARGE T&R | Yes | NIPDAU | Level-2-260C-1 YEAR | -40 to 85 | FR2422 |
| MSP430FR2422IRHLR | Active | Production | VQFN (RHL) 20 | 3000 LARGE T&R | Yes | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | FR2422 |
| MSP430FR2422IRHLR.A | Active | Production | VQFN (RHL) 20 | 3000 LARGE T&R | Yes | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | FR2422 |
| MSP430FR2422IRHLT | Active | Production | VQFN (RHL) 20 | 250 SMALL T&R | Yes | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | FR2422 |
| MSP430FR2422IRHLT.A | Active | Production | VQFN (RHL) 20 | 250 SMALL T&R | Yes | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | FR2422 |

⁽¹⁾ Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

PACKAGE OPTION ADDENDUM

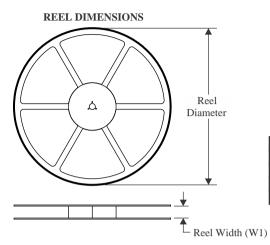
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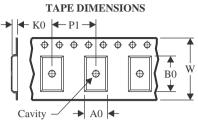
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

PACKAGE MATERIALS INFORMATION

www.ti.com 24-Jul-2025

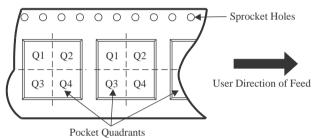
TAPE AND REEL INFORMATION





| A0 | Dimension designed to accommodate the component width |
|----|---|
| В0 | Dimension designed to accommodate the component length |
| K0 | Dimension designed to accommodate the component thickness |
| W | Overall width of the carrier tape |
| P1 | Pitch between successive cavity centers |

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

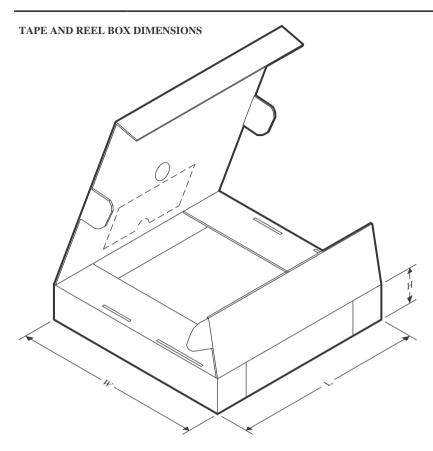


*All dimensions are nominal

| Device | Package Type | Package Drawing | | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|--------------------|-----------------|--------------------|----|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| MSP430FR2422IPW16R | TSSOP | PW | 16 | 2000 | 330.0 | 12.4 | 6.9 | 5.6 | 1.6 | 8.0 | 12.0 | Q1 |
| MSP430FR2422IRHLR | VQFN | RHL | 20 | 3000 | 330.0 | 12.4 | 3.71 | 4.71 | 1.1 | 8.0 | 12.0 | Q1 |
| MSP430FR2422IRHLT | VQFN | RHL | 20 | 250 | 180.0 | 12.4 | 3.71 | 4.71 | 1.1 | 8.0 | 12.0 | Q1 |

PACKAGE MATERIALS INFORMATION

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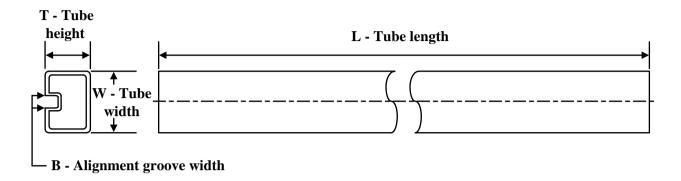
*All dimensions are nominal

| Device | Device Package Type | | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) | |
|--------------------|---------------------|-----|------|------|-------------|------------|-------------|--|
| MSP430FR2422IPW16R | TSSOP | PW | 16 | 2000 | 353.0 | 353.0 | 32.0 | |
| MSP430FR2422IRHLR | VQFN | RHL | 20 | 3000 | 367.0 | 367.0 | 35.0 | |
| MSP430FR2422IRHLT | VQFN | RHL | 20 | 250 | 210.0 | 185.0 | 35.0 | |

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TUBE



*All dimensions are nominal

| Device | Package Name | Package Type | Pins | SPQ | L (mm) | W (mm) | T (µm) | B (mm) |
|---------------------|--------------|--------------|------|-----|--------|--------|--------|--------|
| MSP430FR2422IPW16 | PW | TSSOP | 16 | 90 | 530 | 10.2 | 3600 | 3.5 |
| MSP430FR2422IPW16.A | PW | TSSOP | 16 | 90 | 530 | 10.2 | 3600 | 3.5 |

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最后更新日期: 2025 年 10 月